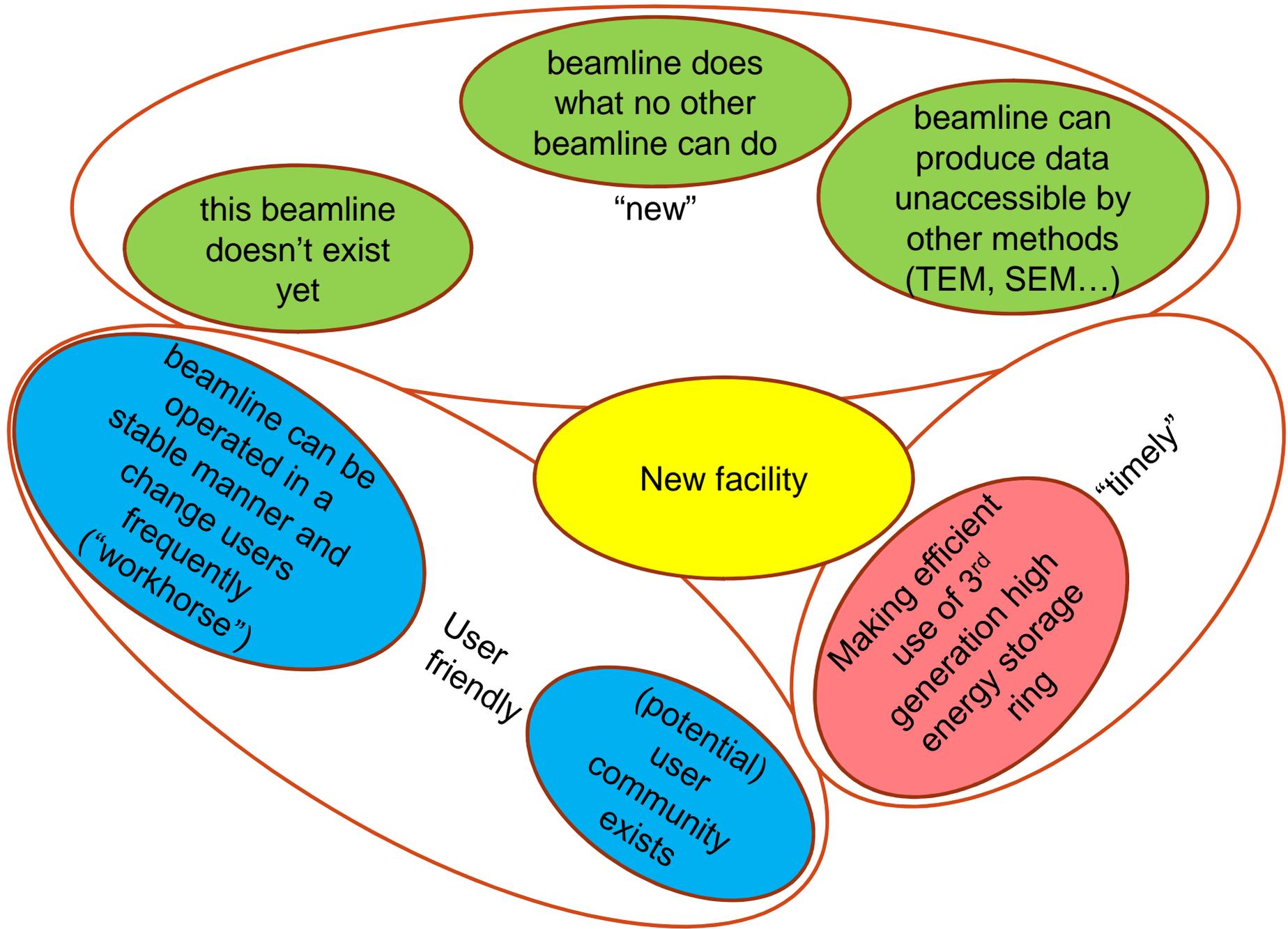




New facilities for applied surface science at 3<sup>rd</sup>  
generation synchrotron sources

..how new is new ?  
A beamline scientists' point of view

T. U. Schüllli APS workshop January 2012



beamline does what no other beamline can do

“new”

beamline can produce data inaccessible by other methods (TEM, SEM...)

this beamline doesn't exist yet

New facility

beamline can be operated in a stable manner and change users frequently (“workhorse”)

User friendly

(potential) user community exists

Making efficient use of 3<sup>rd</sup> generation high energy storage ring

“timely”

# Outline

Observation of growth processes: Interface induced supercooling: An X-ray view on liquid – solid interaction

Surfaces studied with submicronic beams



2003-2009

**BM32**

**IF**

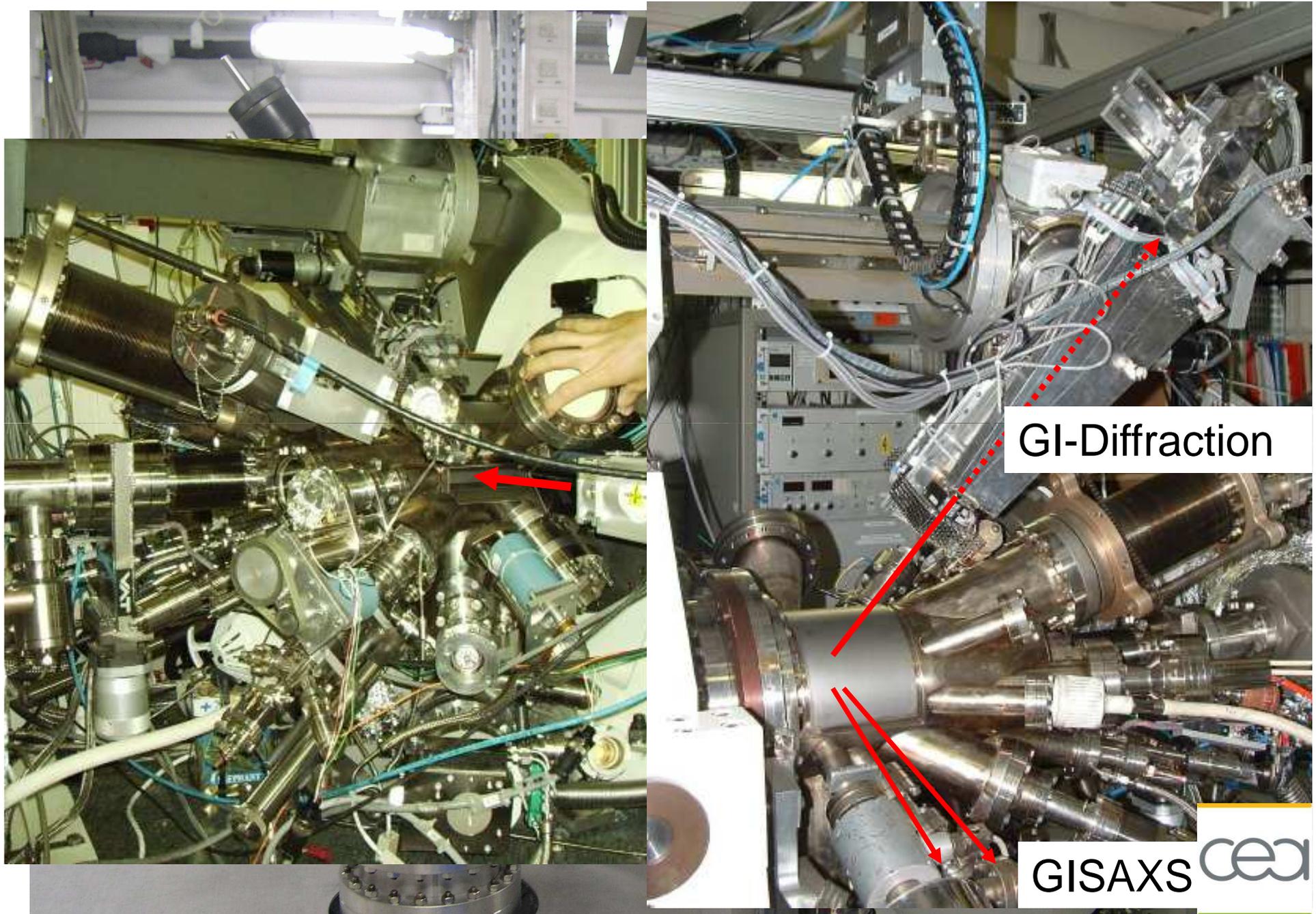
Anomalous Scattering Beamline



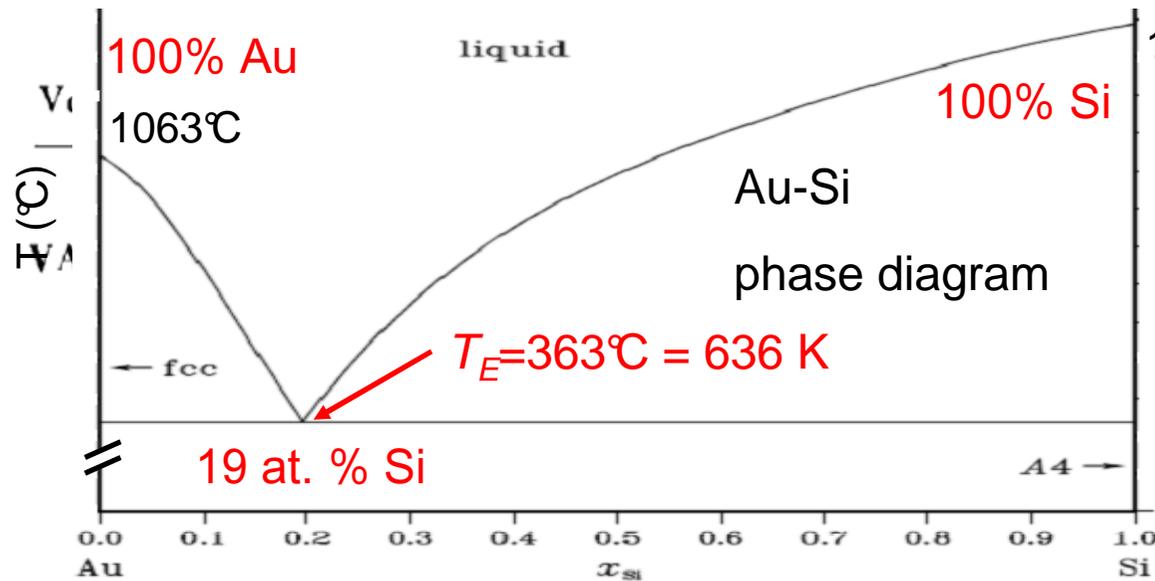
ESRF

The logo for the ID1 Anomalous Scattering Beamline at ESRF. It features a blue gear-like circle with 'ID1' inside, a red and blue beamline diagram, and the text 'ESRF' below.

# BM32 MBE in situ growth chamber

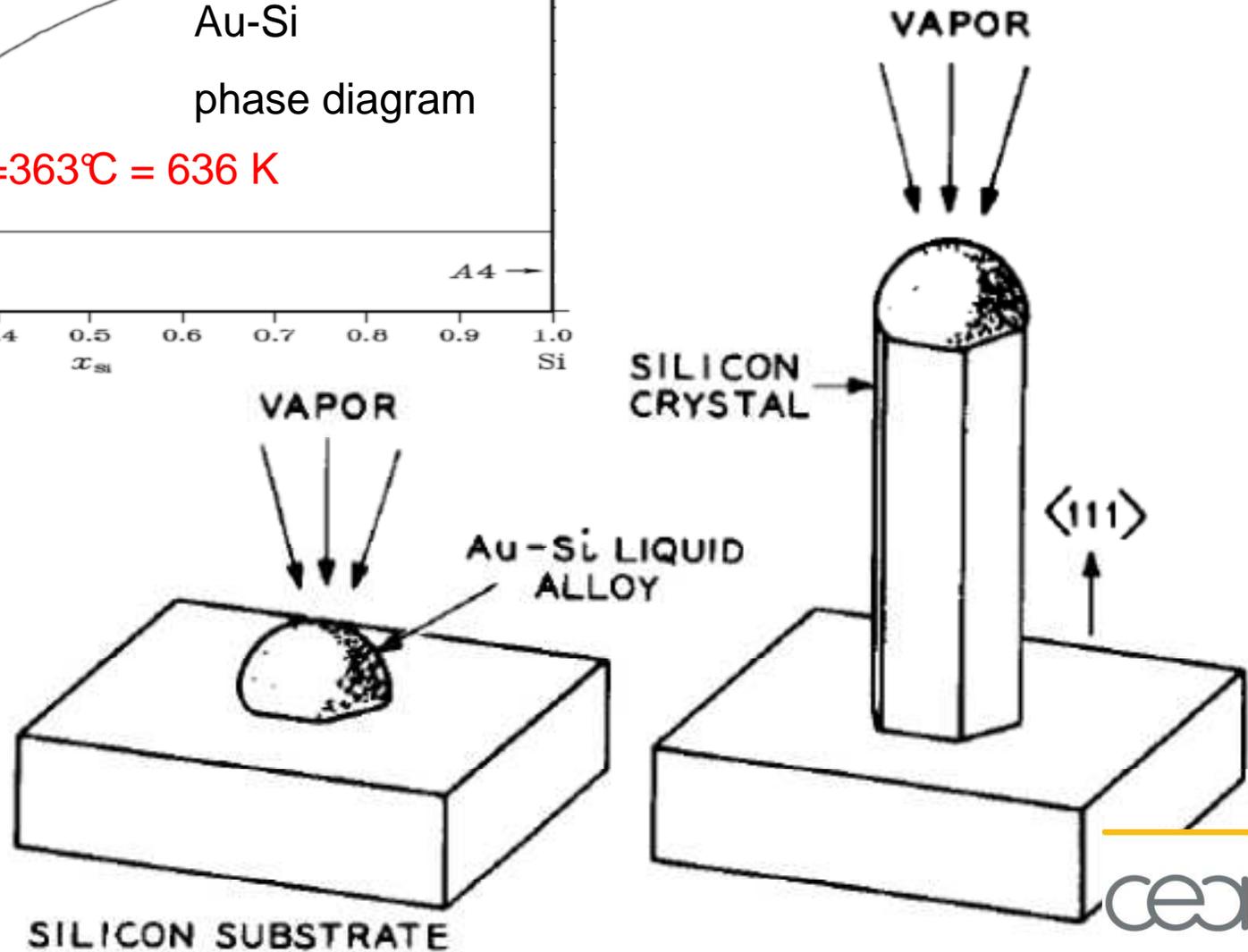


# Vapour-Liquid-Solid growth



TTERS

1 March 1964

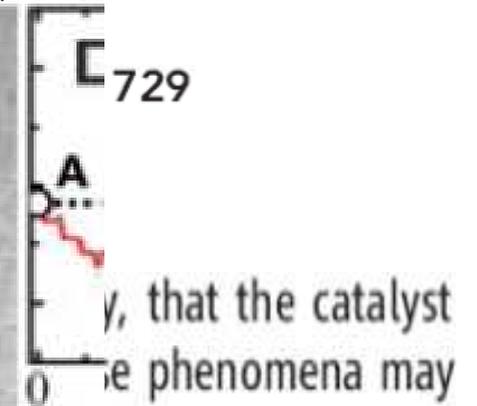
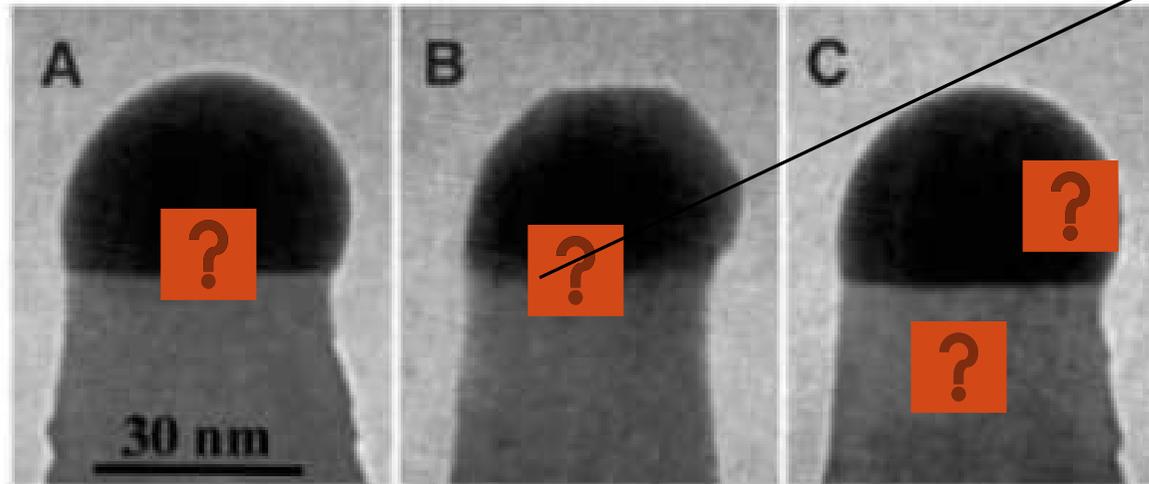


# Germanium Nanowire Growth Below the Eutectic Temperature

S. Kodambaka,\* I. Tersoff, M. C. Reuter, F. M. Ross†

“Supercooling”

either liquid  
state depend



Why add a gas-source?

CVD is the most applied growth mode in silicon and SiGe technology and beyond (SiC, nanowires, Graphene, Diamond... )

2005:



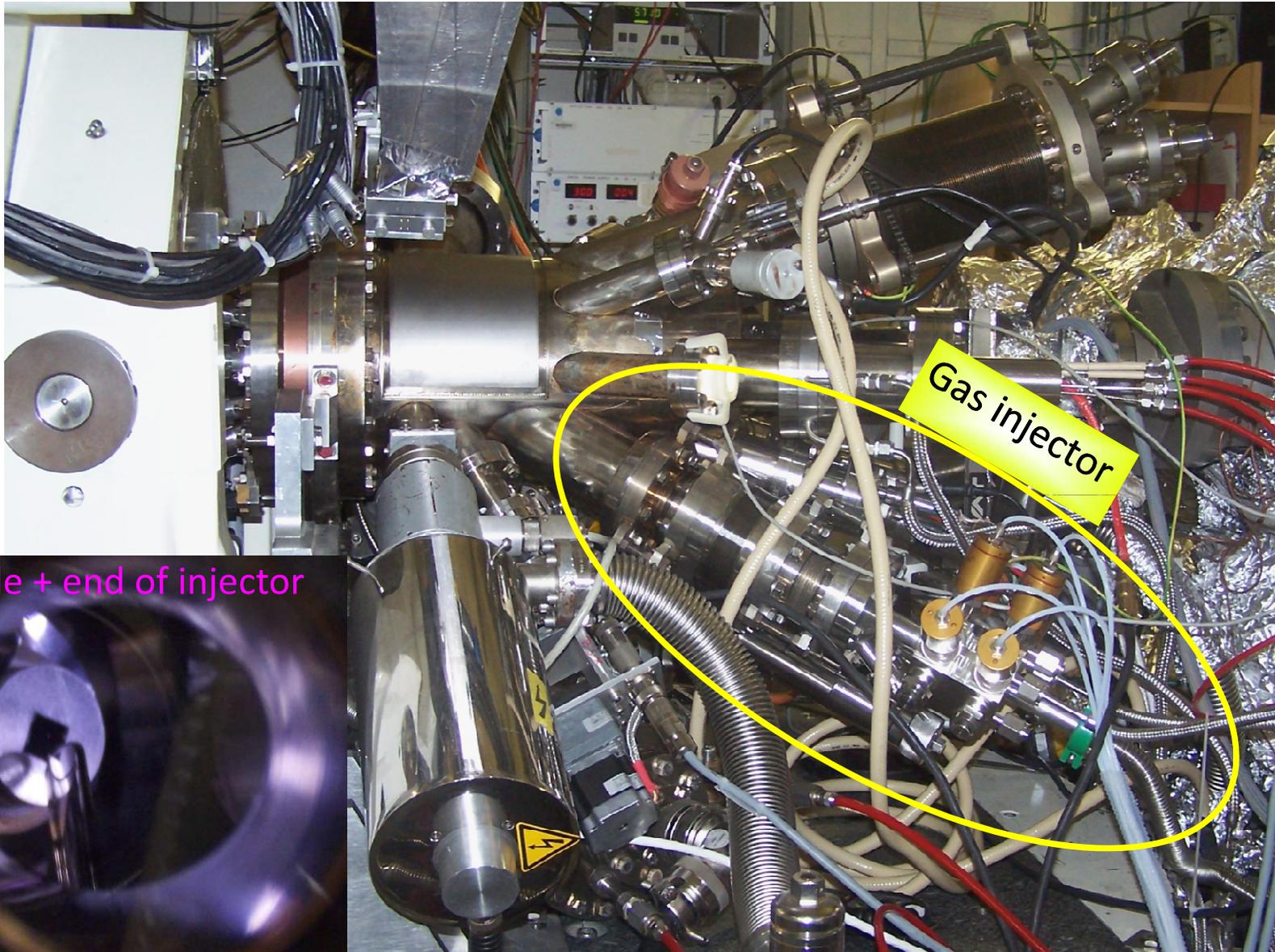
First approach to safety engineers



Final safety validation 04/2009

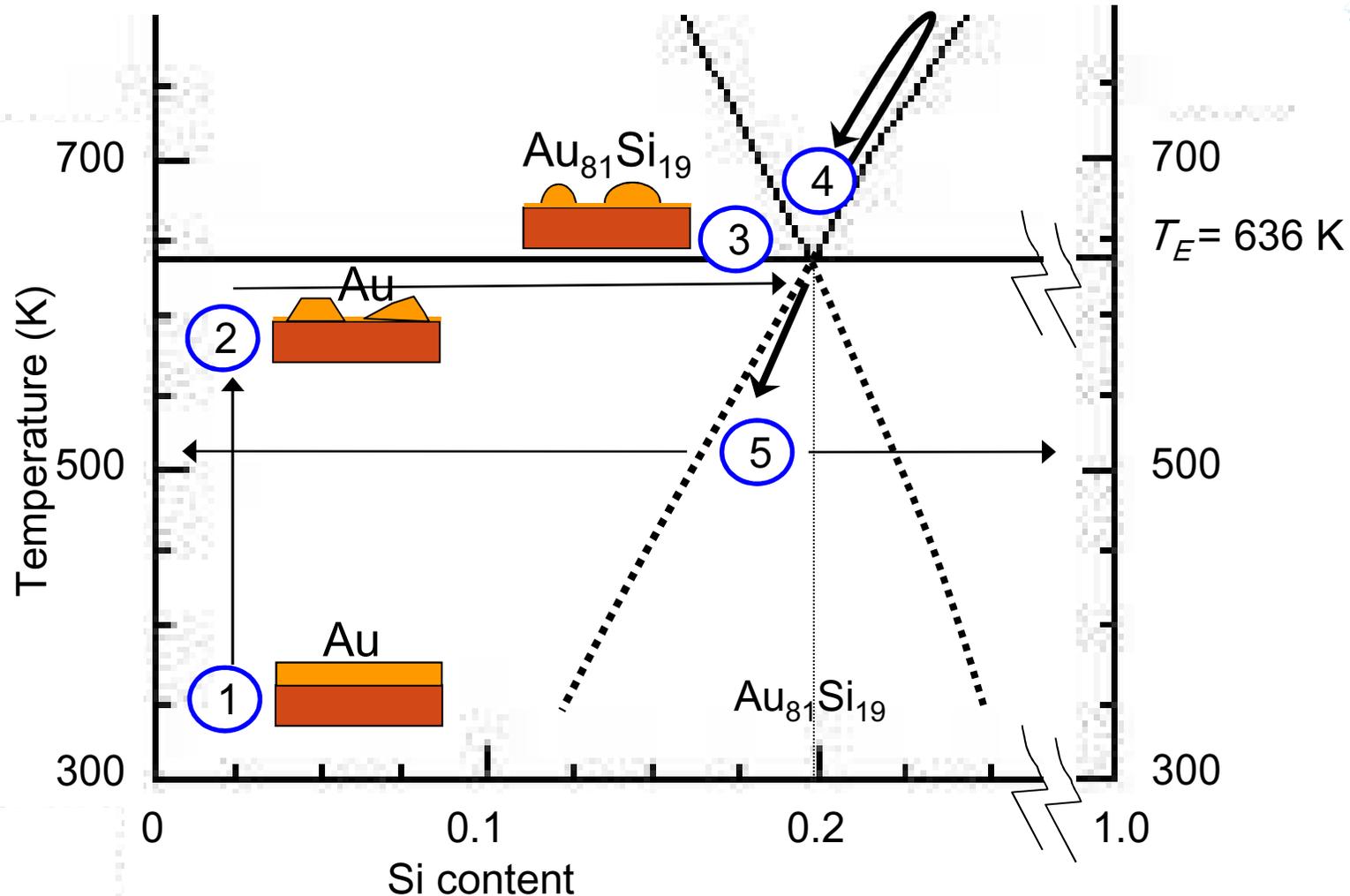
2007: Funding obtained by *nano* SCIENCES

# Injector tested, Gas-bottles installed, first wires grown in 2011

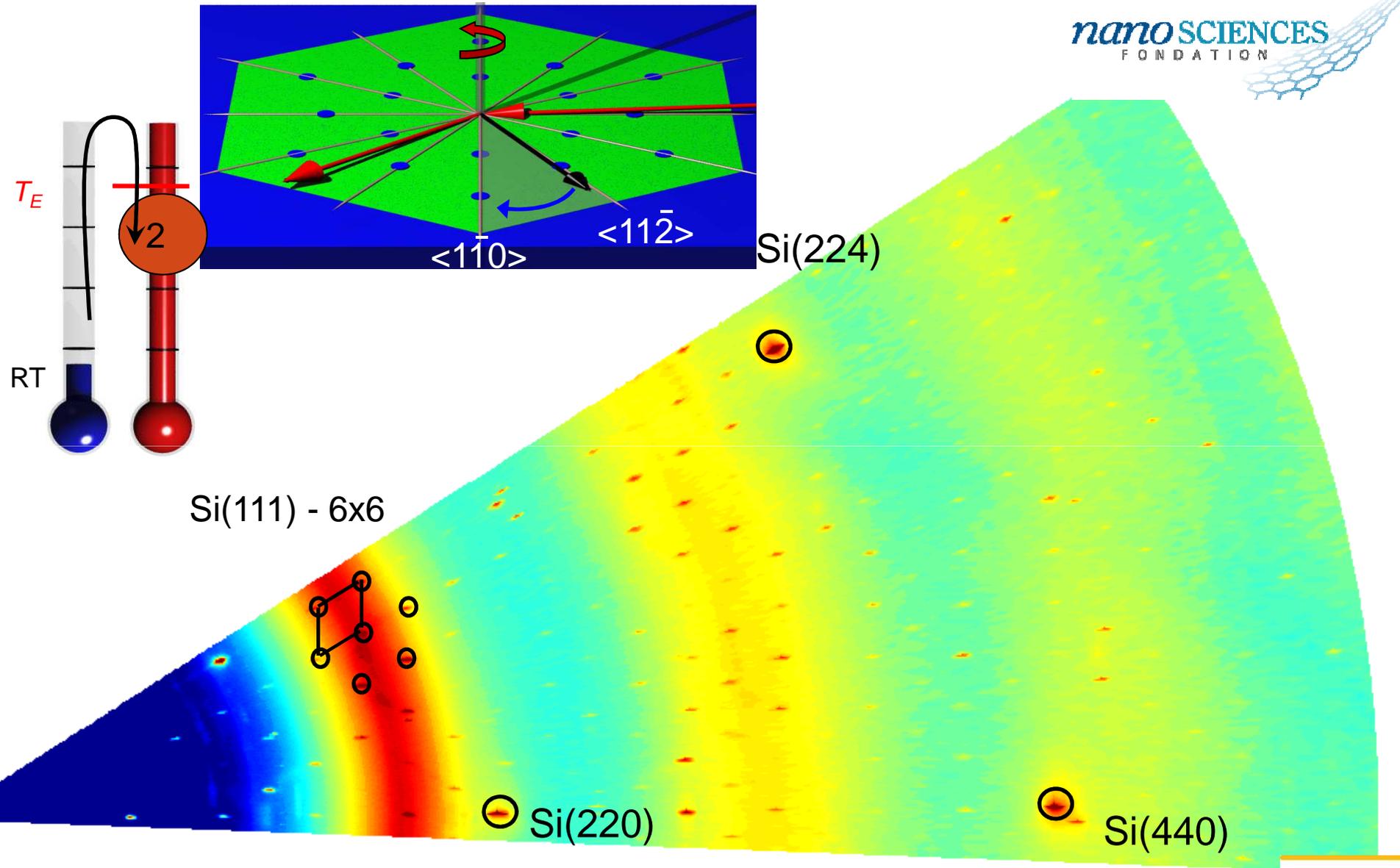


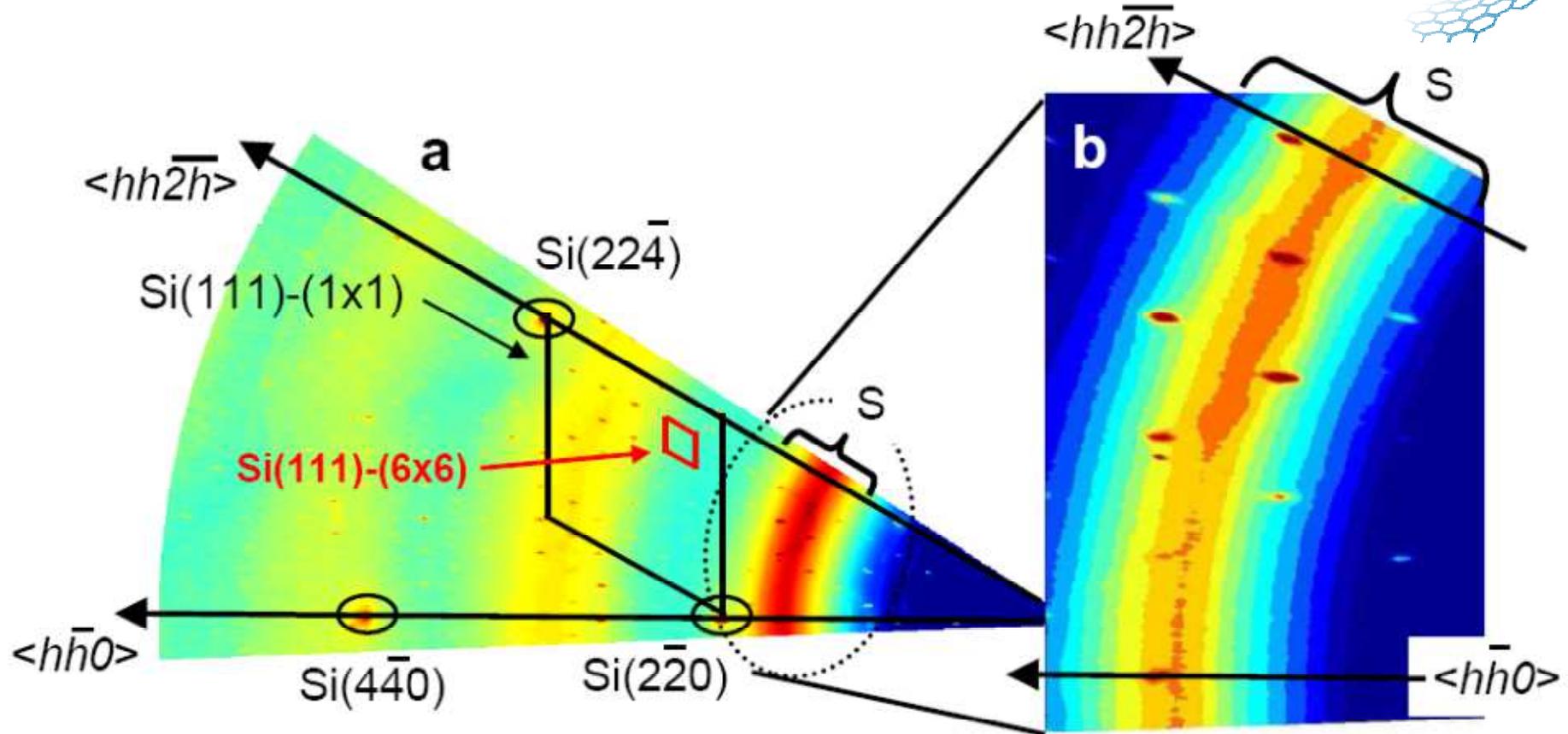
Sample + end of injector

# Nucleation and Solid-Liquid Transition of AuSi Nanowire Catalysts on Si(111)



Systematic X-ray measurements performed in all the above different states of the phase diagram.

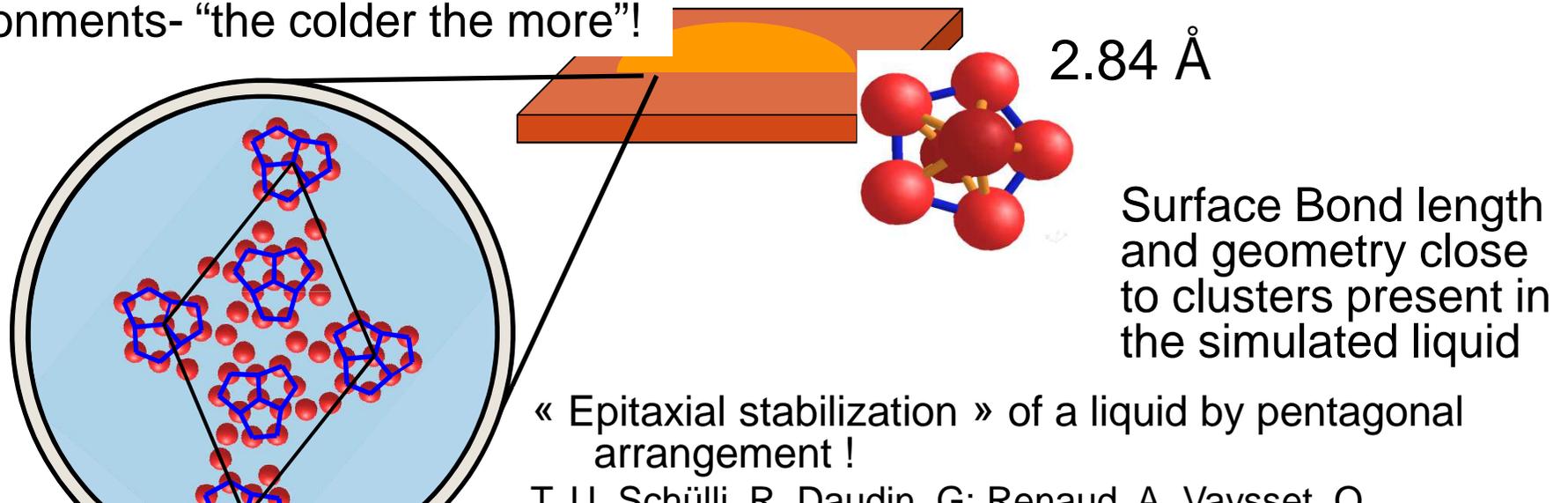




There must be a structural similarity between the 6x6 structure and the short range order of the adjacent liquid layers

T. U. Schüllli, R. Daudin, G. Renaud, A. Vaysset, O. Geaymond, A. Pasturel, Nature 464, (2010).

Molecular dynamics simulations of the “free liquid”: ~30-40% of the atoms are in icosahedral environments- “the colder the more”!



NANO LETTERS

Nano Lett 11, 44 (2011).

2.9 Å)

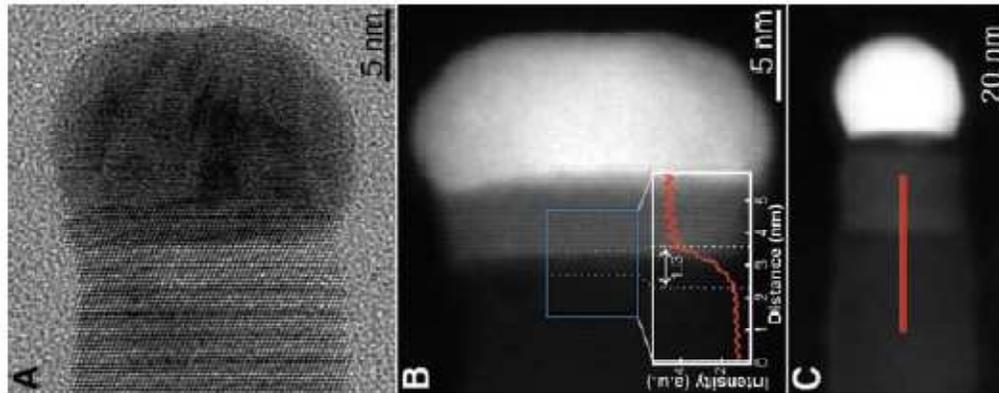
[pubs.acs.org/NanoLett](http://pubs.acs.org/NanoLett)

## Formation of Wurtzite InP Nanowires Explained by Liquid-Ordering

Rienk E. Algra,<sup>†,†,§</sup> Vedran Vonk,<sup>§</sup> Didier Wermeille,<sup>||</sup> Wiesiek J. Szweryn,<sup>§</sup> Marcel A. Verheijen,<sup>†</sup> Willem J. P. van Enckevort,<sup>§</sup> Arno A. C. Bode,<sup>§</sup> Wim L. Noorduin,<sup>§</sup> Erik Tancini,<sup>||</sup> Aryan E. F. de Jong,<sup>§</sup> Erik P. A. M. Bakkers,<sup>†,‡</sup> and Elias Vlieg<sup>\*,§</sup>

# Conclusion on *in situ* UHV-CVD

Facility is producing NW using CVD, but NW field is very competitive; in particular NWs are good samples for in situ SE



SCIENCE VOL 326 27 NOVEMBER 2009

## Formation of Compositionally Abrupt Axial Heterojunctions in Silicon-Germanium Nanowires

C.-Y. Wen,<sup>1</sup> M. C. Reuter,<sup>2</sup> J. Bruley,<sup>2</sup> J. Tersoff,<sup>2</sup> S. Kodambaka,<sup>3</sup> E. A. Stach,<sup>1</sup> F. M. Ross<sup>2\*</sup>

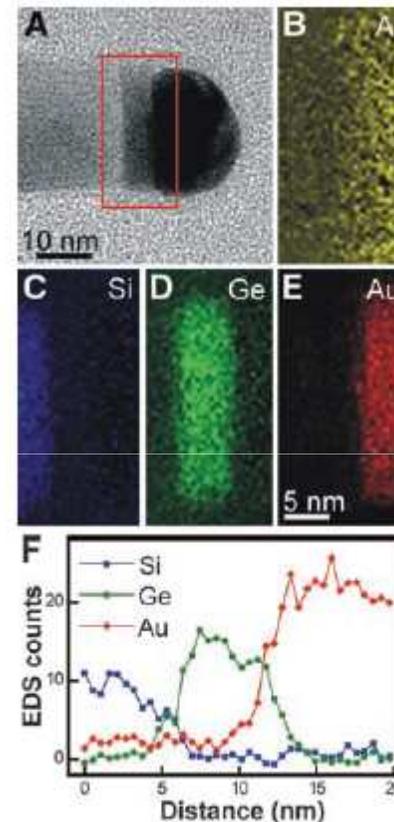
Definitely gas environments are of interest.

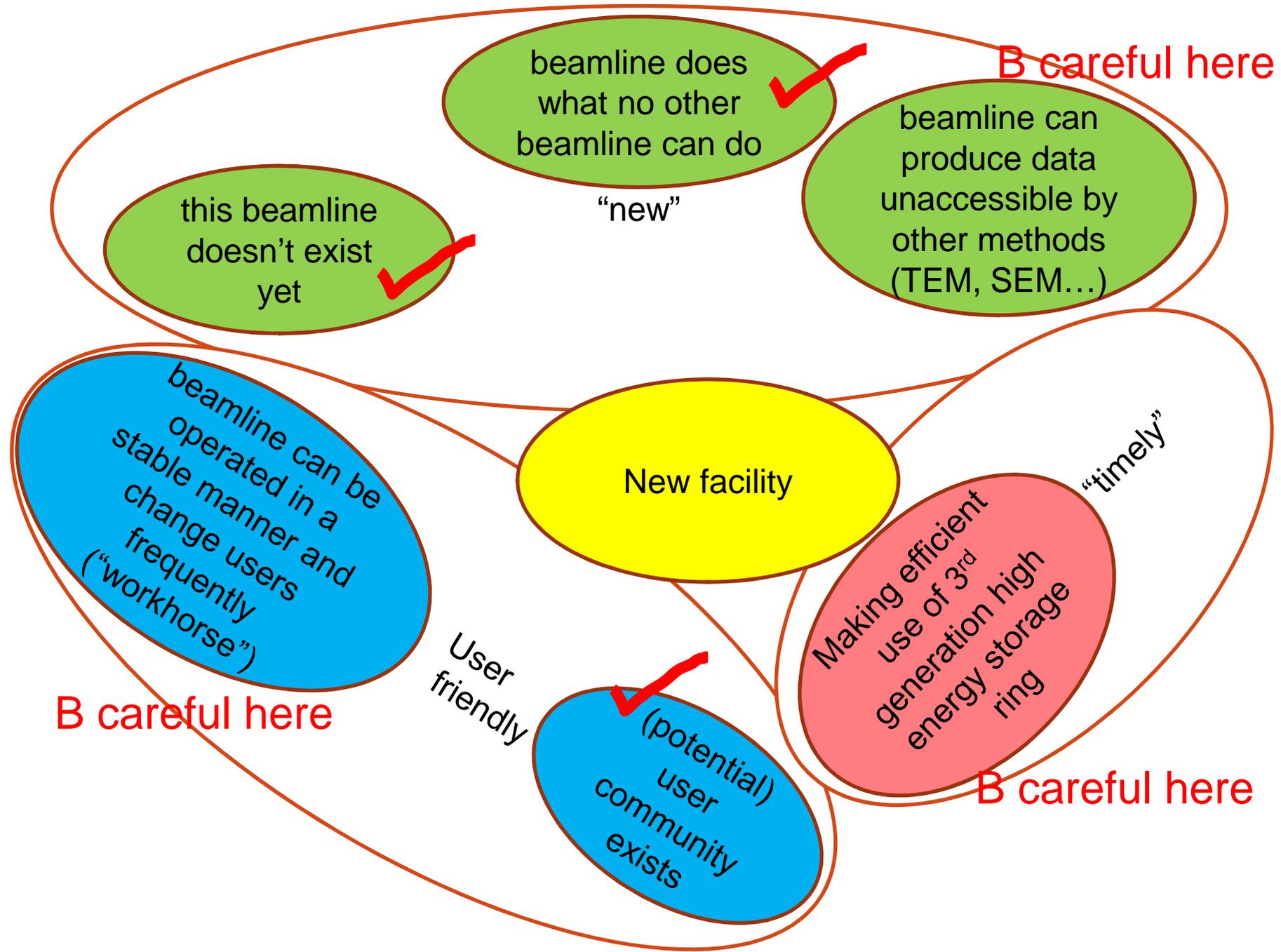
Installed on BM32

Above 1 mbar: electron techniques are out of competition

-> catalysis, working fuel cells,...

-> a lot to do beyond UHV (simpler sample environment, less dedicated BL!)





beamline does what no other beamline can do ✓

"new"

B careful here

beamline can produce data inaccessible by other methods (TEM, SEM...)

this beamline doesn't exist yet ✓

New facility

beamline can be operated in a stable manner and change users frequently ("workhorse")

B careful here

User friendly

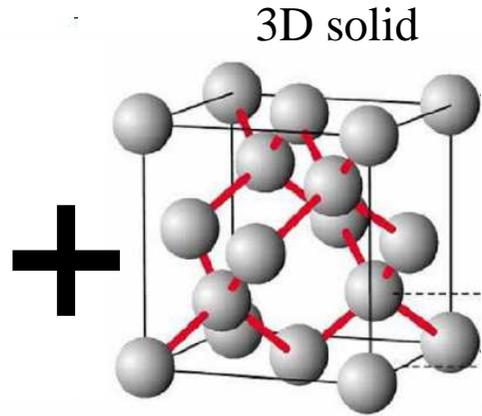
(potential) user community exists ✓

Making efficient use of 3<sup>rd</sup> generation high energy storage ring

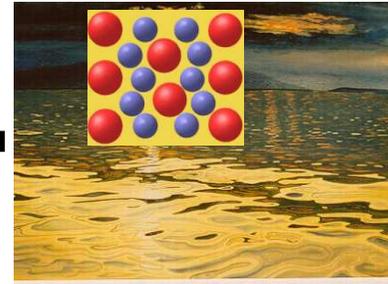
B careful here

"timely"

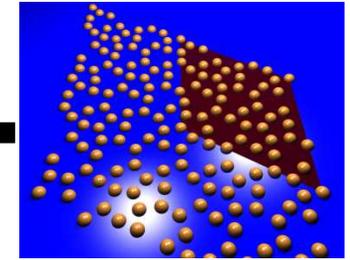
# Complexity!



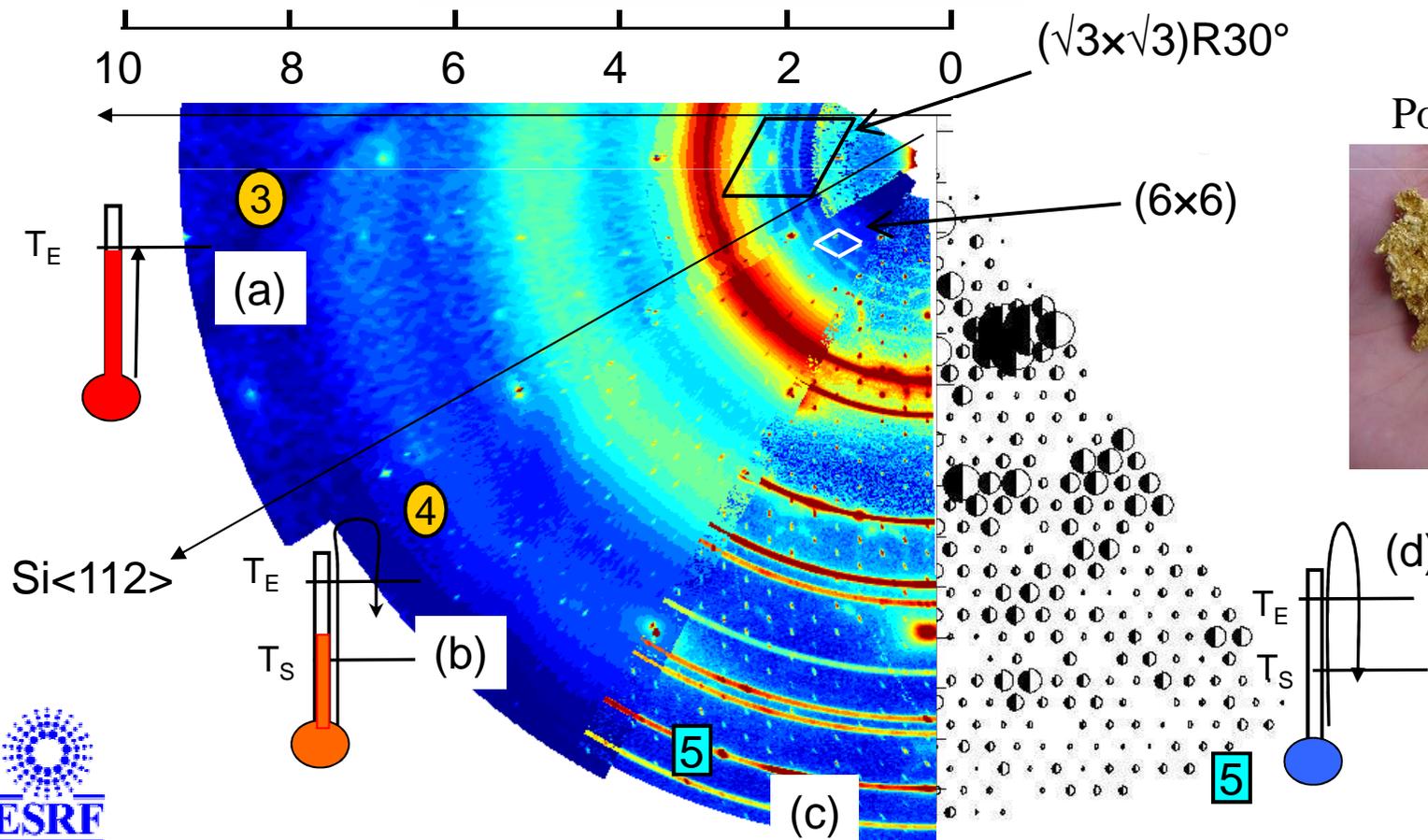
2D AuSi phases  
floating on liquid  
AuSi (*Shpyrko et al., Science 2007*)



2D interfacial  
structures



Polycrystalline Gold



## Complexity, -from surface science to device structures

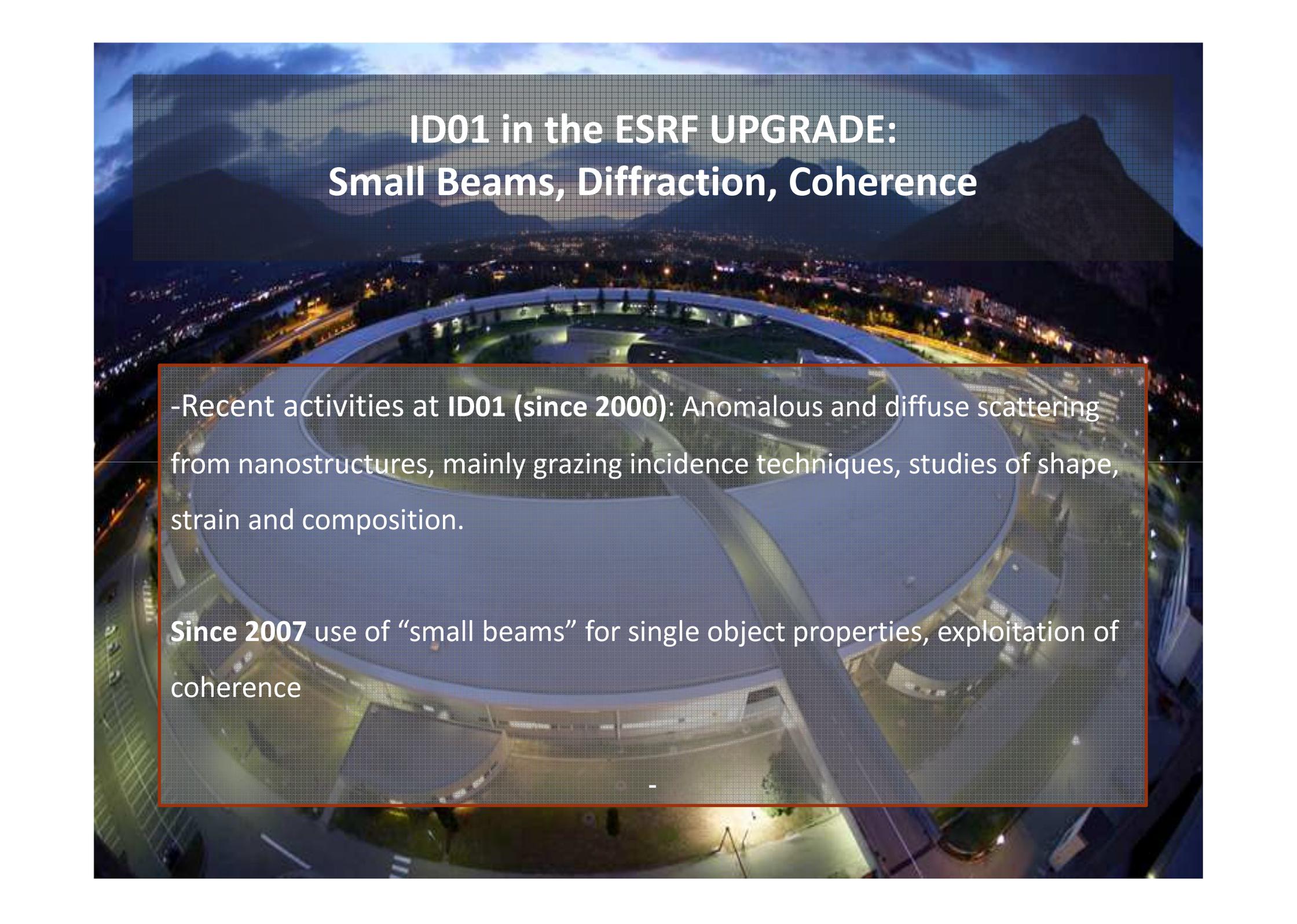
More complex growth processes, or reactions involving heterogeneous structures

Open the field for sub-micronic beams

This is one technique where 3<sup>rd</sup> generation high energy storage rings meet requirements to generate new knowledge in surface and nano science.

Small beams are good to be used

1. When heterogeneity does not allow conclusive measurements with big beams
2. *in operando* experiments require “individual” measurements (electromigration breakdown phenomena in devices, mechanical testing of nanostructures/ wires).



# ID01 in the ESRF UPGRADE: Small Beams, Diffraction, Coherence

-Recent activities at **ID01 (since 2000)**: Anomalous and diffuse scattering from nanostructures, mainly grazing incidence techniques, studies of shape, strain and composition.

**Since 2007** use of “small beams” for single object properties, exploitation of coherence

# ESRF+ID01 Upgrade 2008-2017

No dedicated diffractometer at that time,  
Triggered idea of the upgrade

PHYSICAL REVIEW B 77, 245425 (2008)

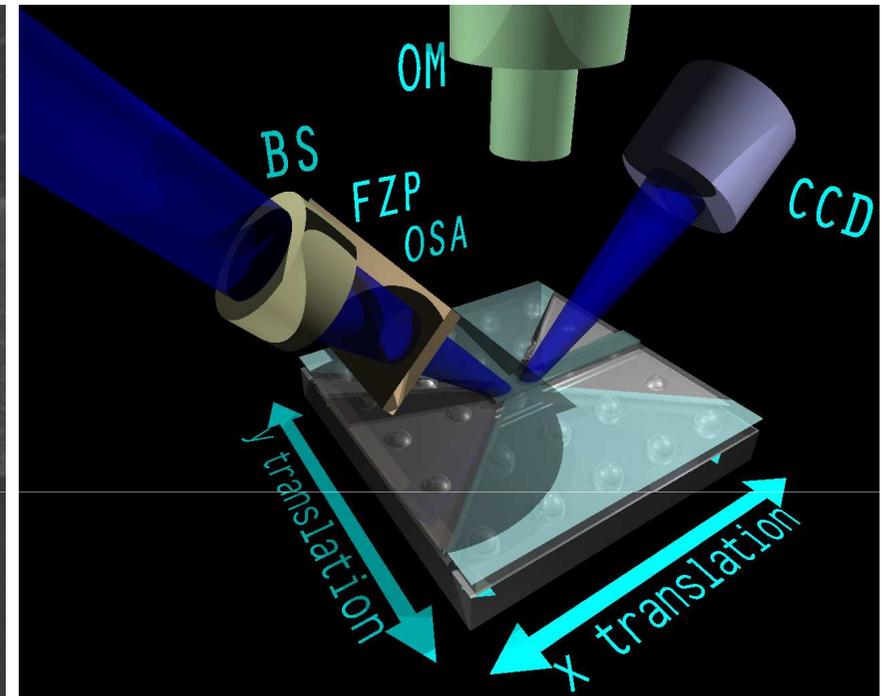
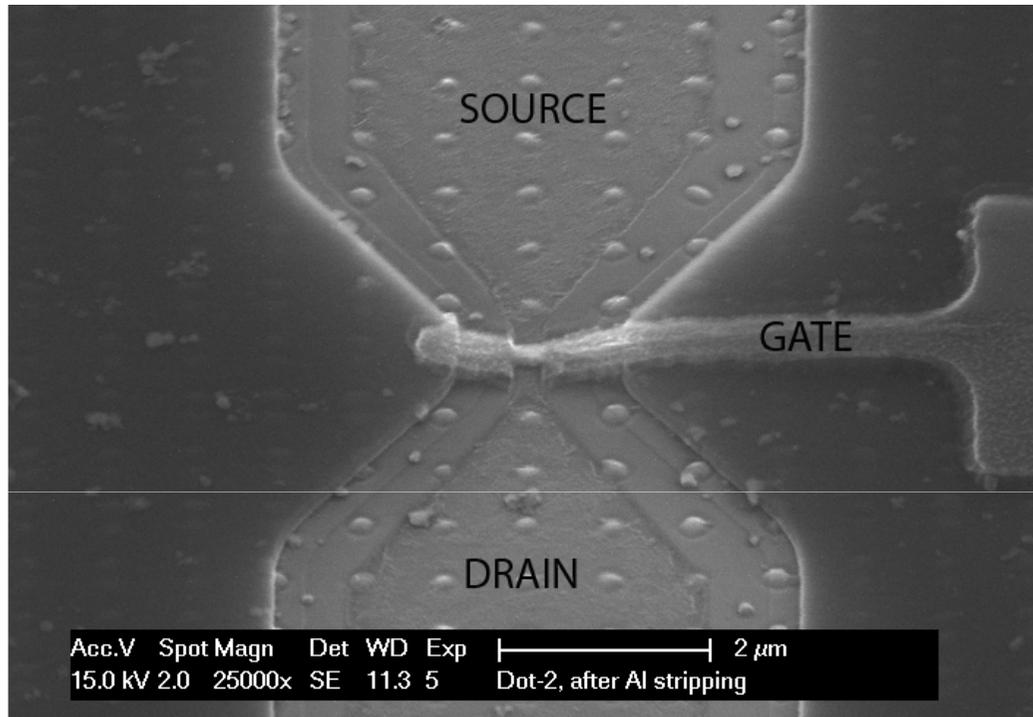
Beyond the ensemble average: X-ray microdiffraction analysis of single SiGe islands

C. Mocuta,<sup>1</sup> J. Stangl,<sup>2</sup> K. Mundboth,<sup>1,2</sup> T. H. Metzger,<sup>1</sup> G. Bauer,<sup>2</sup> I. A. Vartanyants,<sup>3</sup> M. Schmidbauer,<sup>4</sup> and T. Boeck<sup>4</sup>



Id01 upgrade until 2013:  
Beamsizes below 50 nm

# Diffraction as a local tool, study of devices: Shedding light onto the heart of a transistor

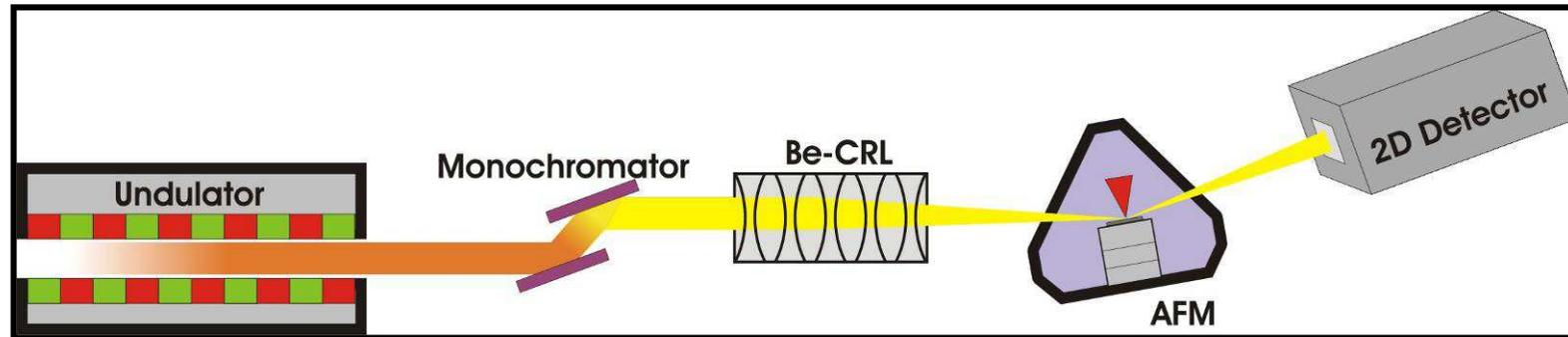


*Strain determination in the Si channel above a single SiGe island inside a field effect transistor using nanobeam x-ray diffraction*

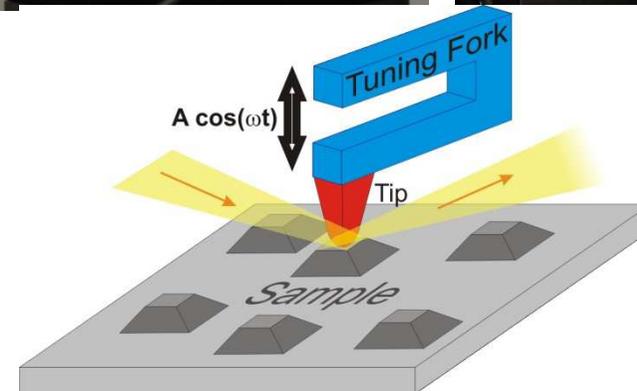
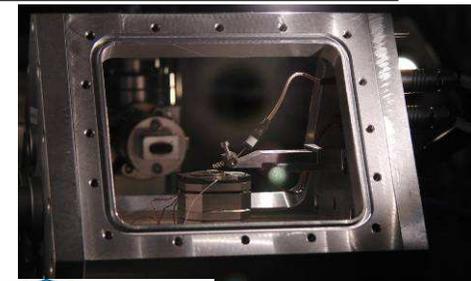
N. Hrauda et al. *Nano Letters* 2011, **11**, 2875

# Experimental setup for elastic studies on nanoscale

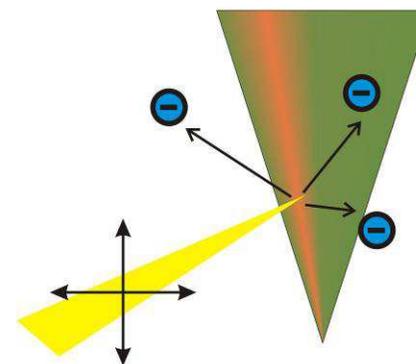
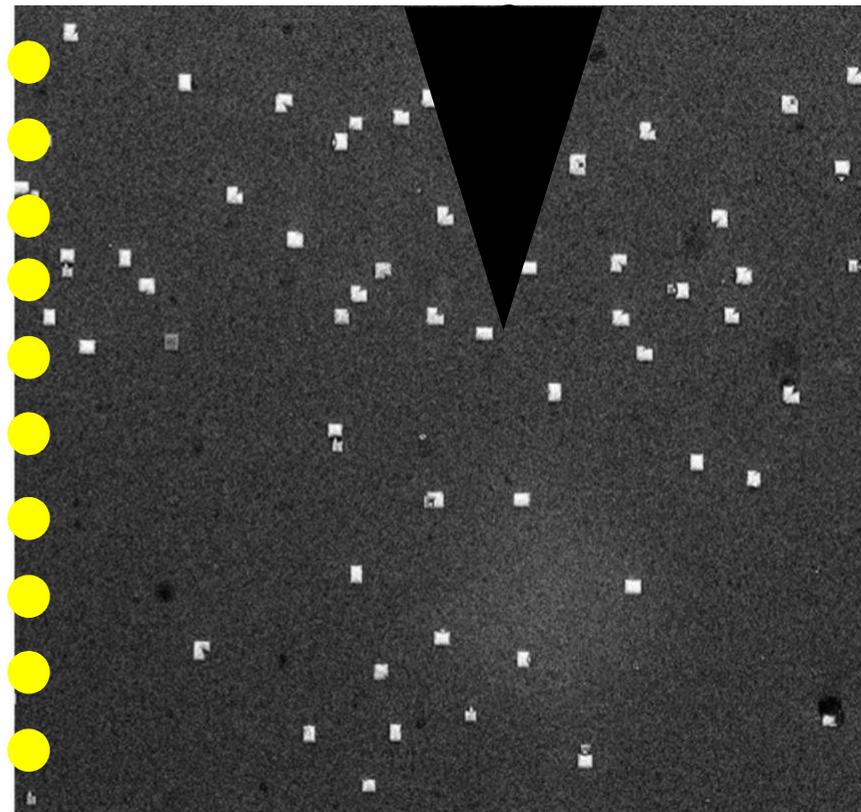
## Combination of *in-situ* AFM and microfocused XRD



- ❖ X-ray beam focused to  $1.5 \times 3 \text{ mm}^2$  by Be-CRLs
- ❖ AFM constructed by Small Infinity™
- ❖ AFM used both to image and to manipulate single nanostructures



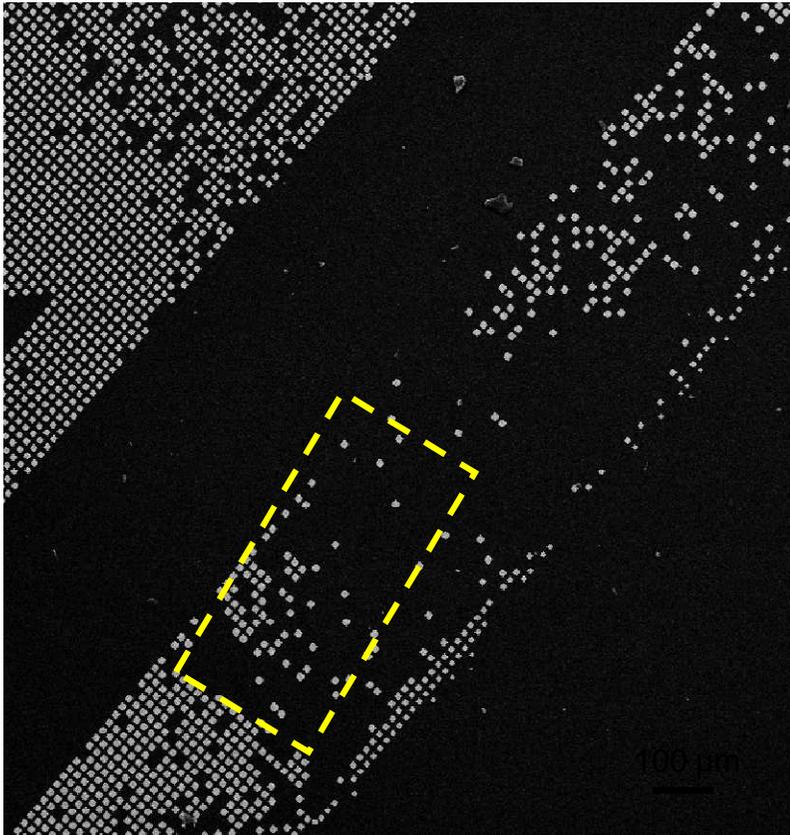
# Sample alignment



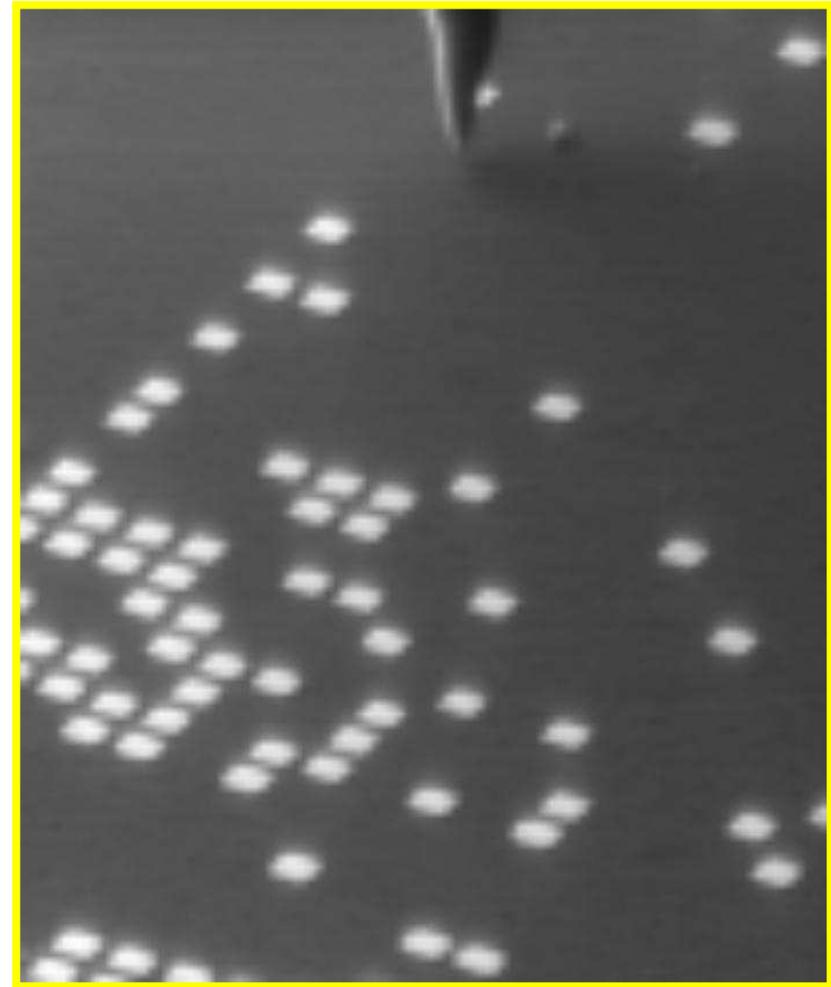
X-ray excited **photoelectrons**  
can be used to **image** AFM tip

Simultaneously to photocurrent  
acquisition, **scattered X-rays** recorded

# Sample alignment

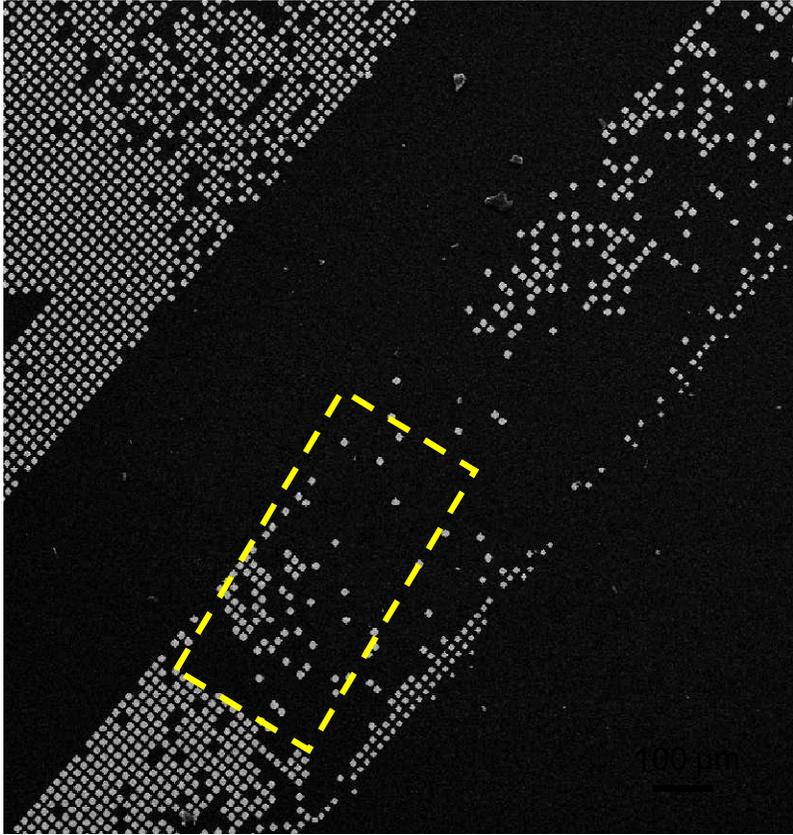


**SEM**



**Photocurrent imaging (PI)**

polycrystalline Bi islands with grain size  $\sim 500$  nm

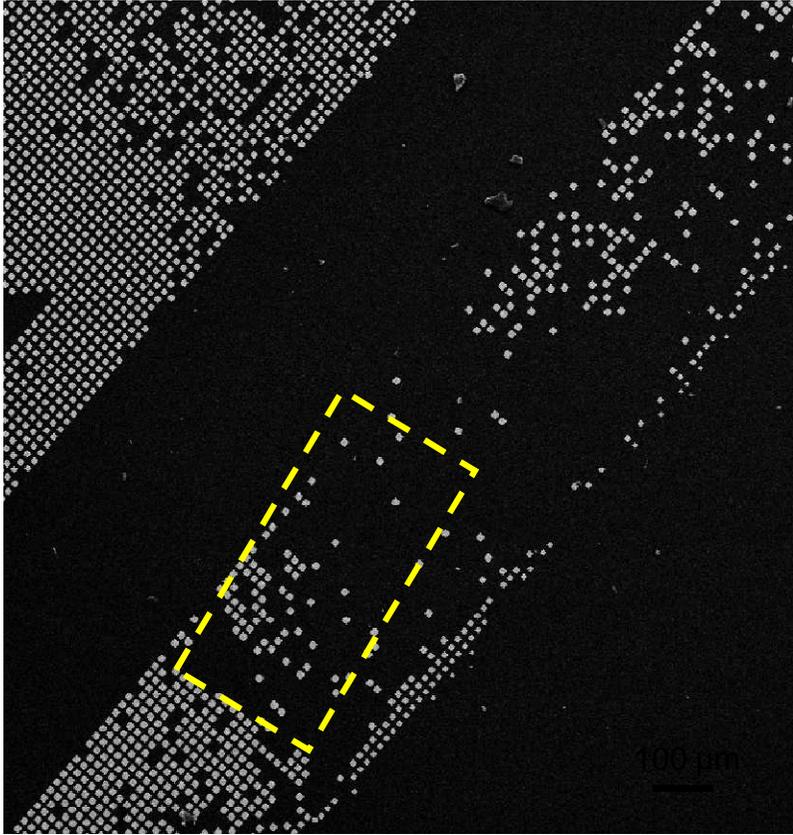


SEM

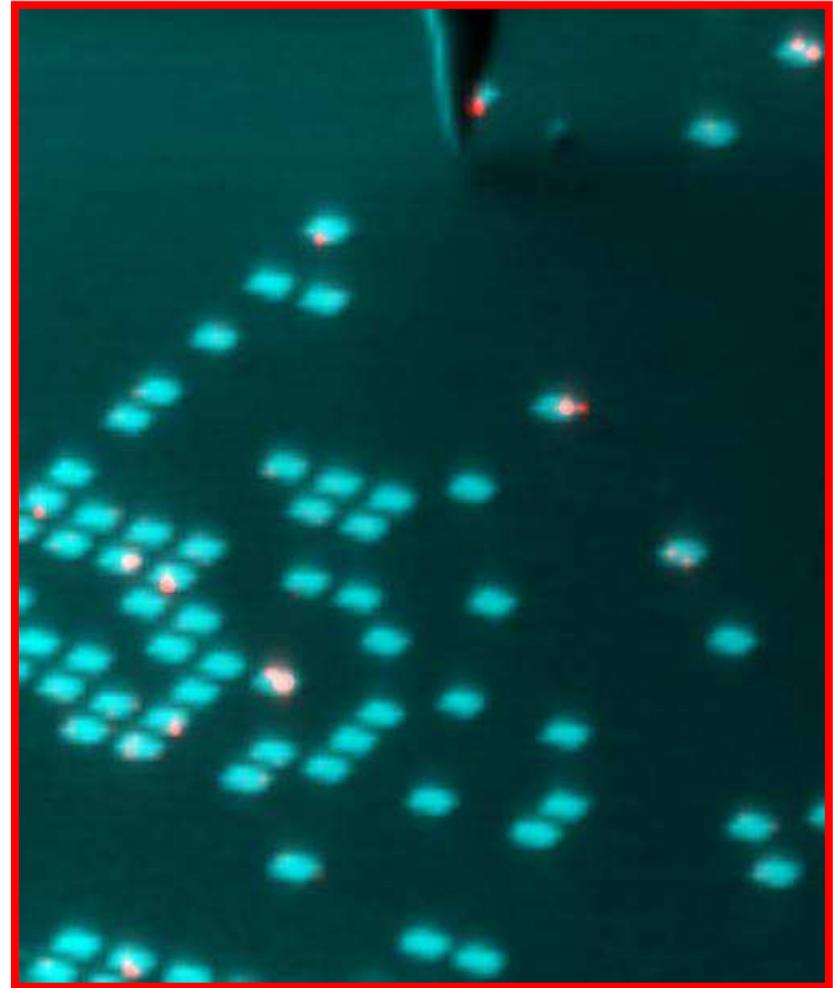


XRD

polycrystalline Bi islands with grain size  $\sim 500$  nm



SEM



PI + XRD

polycrystalline Bi islands with grain size  $\sim 500$  nm

# New diffractometer required

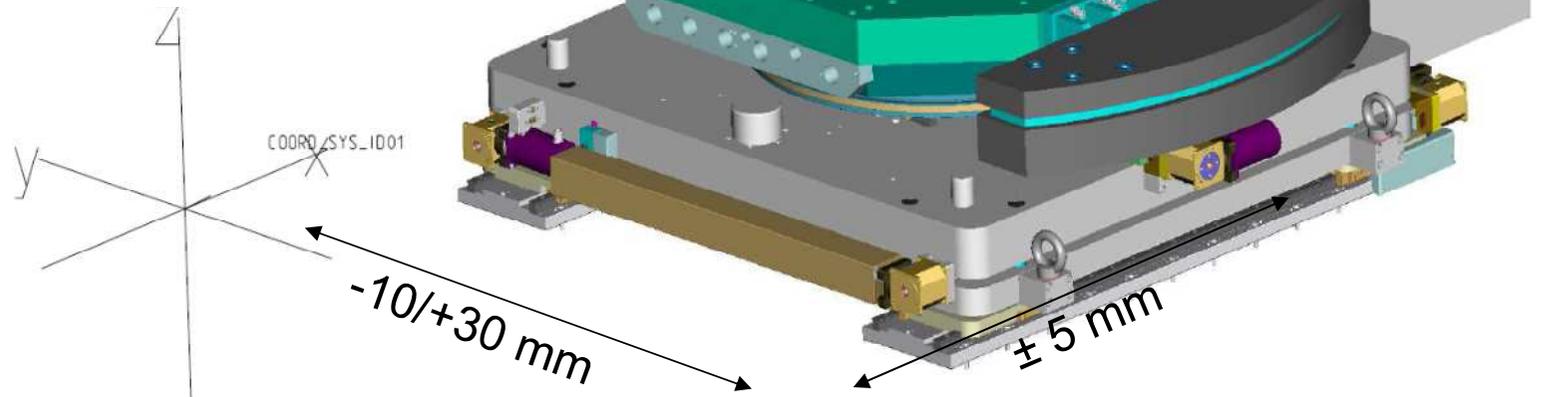
## CHARACTERISTICS

3+2 circles - reduced Sphere of Confusion ( $15\mu\text{m}$  full, and  $100\text{nm}$  within  $\pm 1^\circ$ )

Sample and optics on same granite table

Sample and Detector support decoupled

Hexapod for sample & light-weight sample environment positioning ( $100\text{nm}$  step on  $12\text{mm}$  stroke)

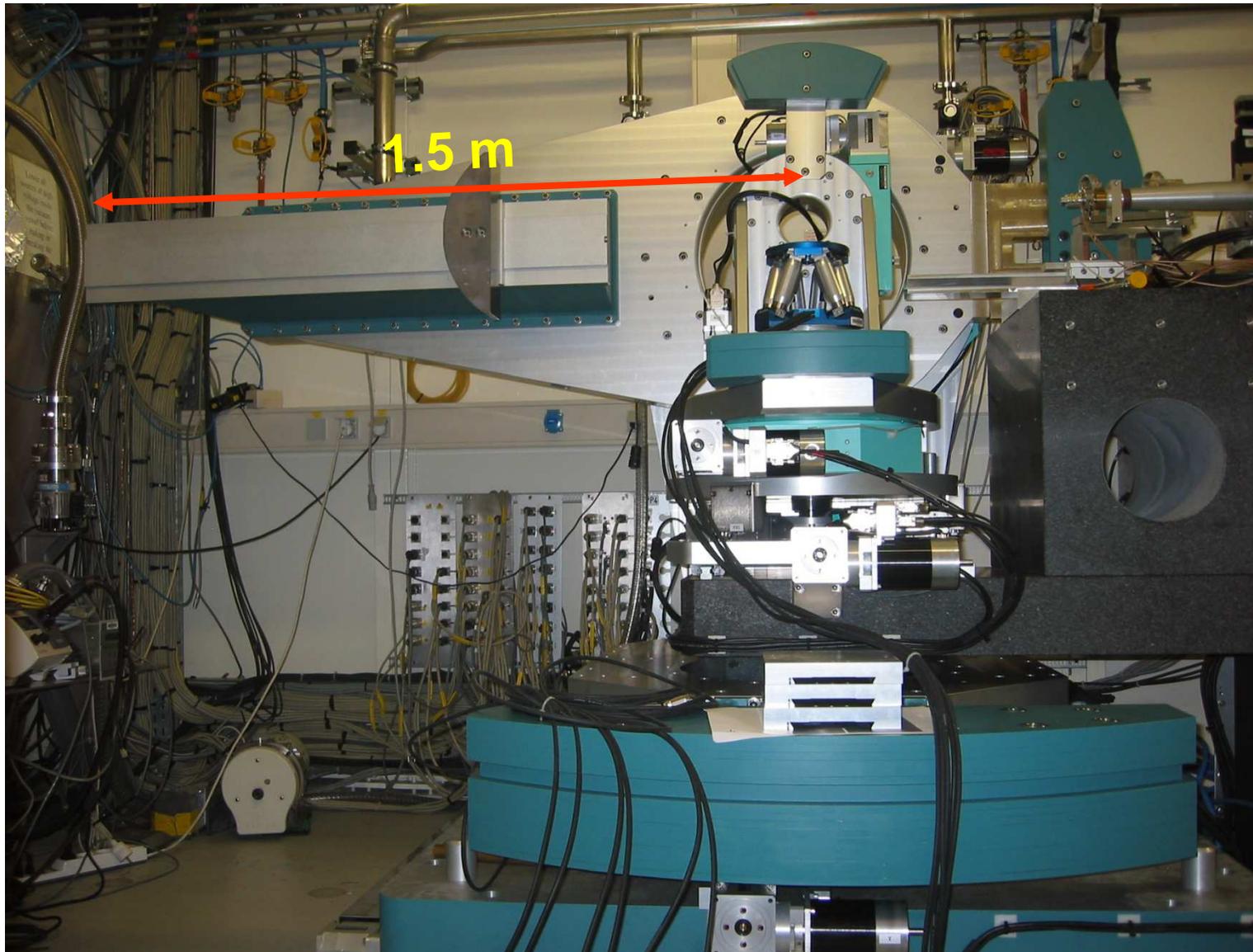


# New Huber diffractometer

Arrival x-mas 2010 installation January 2011



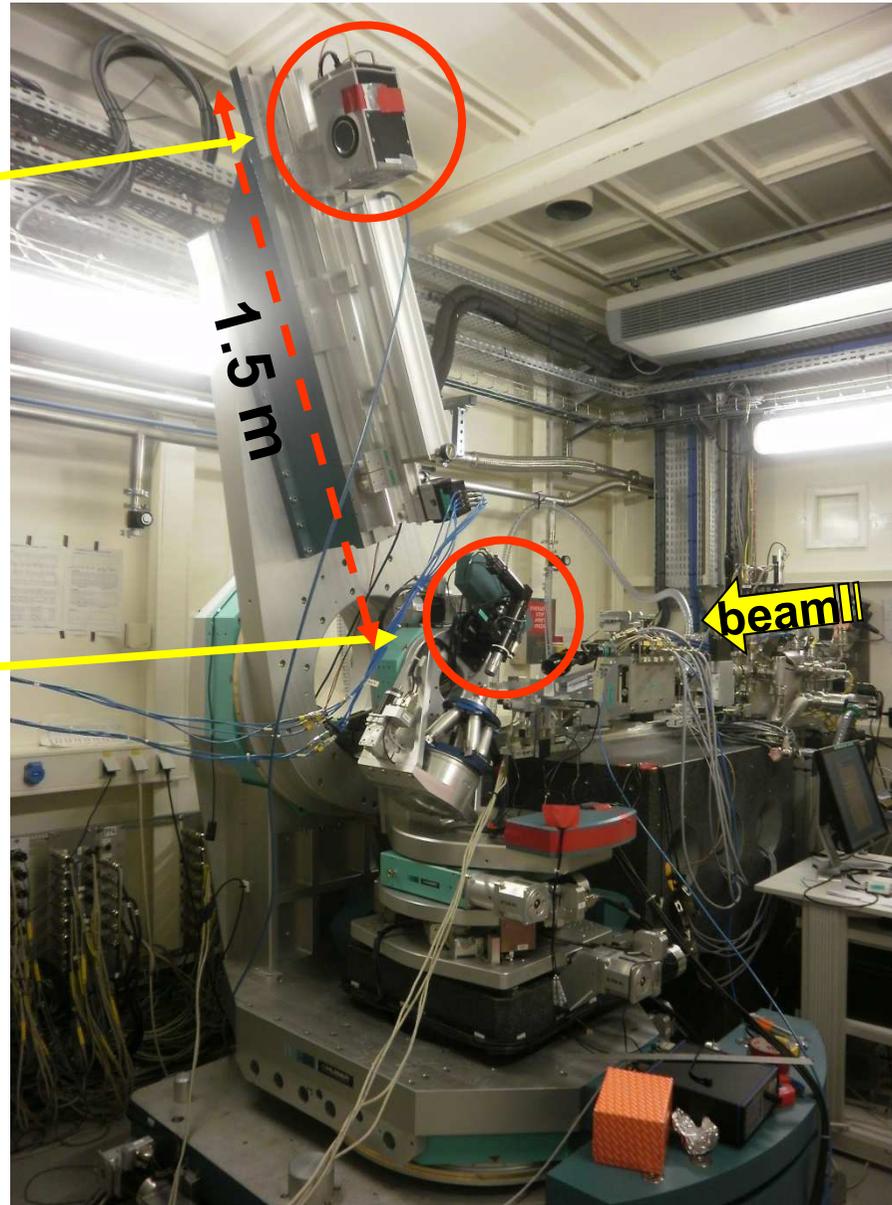
# New Huber diffractometer



new Maxipix  
with 4 chips  
(512 x 512 pixels)

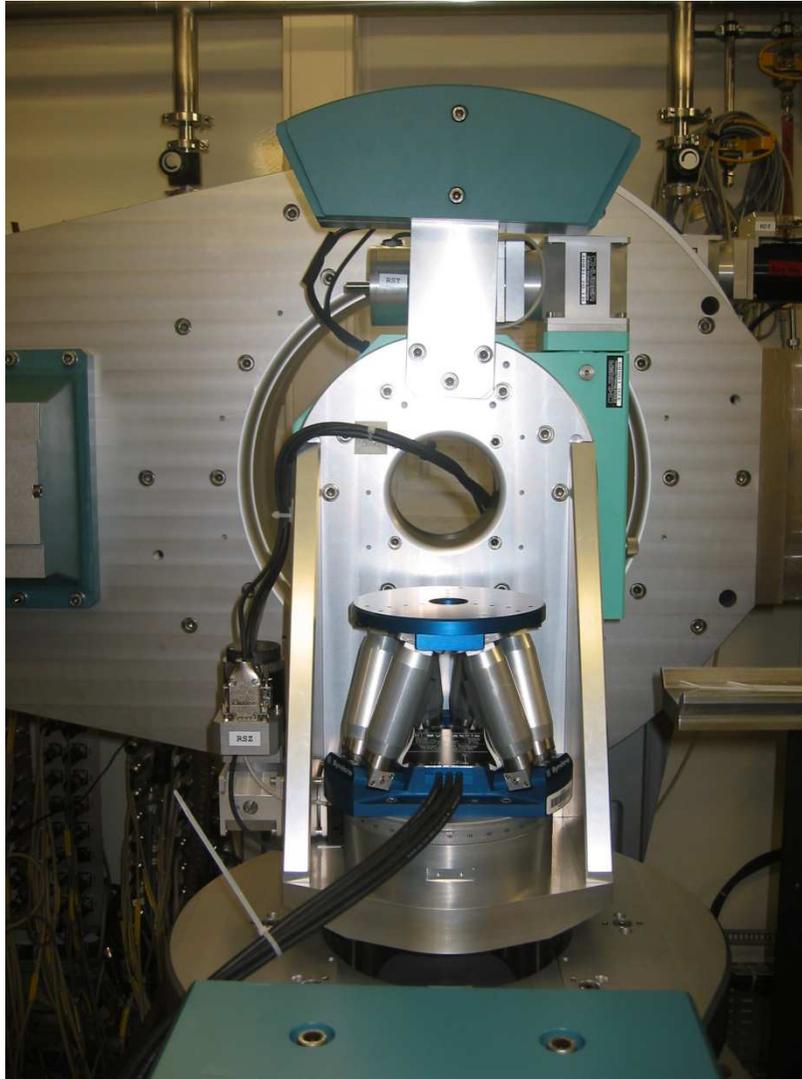
allows image  
accumulation

new optical  
microscope  
(resolution: 500 nm)



detector arm and  
sample stage  
mechanically  
decoupled

# Symétrie hexapod



## **translation**

$$x, y, z = \pm 5 \text{ mm}$$

$$\Delta x, \Delta y, \Delta z = 100 \text{ nm}$$

## **rotation**

$$\Omega = \pm 5^\circ$$

## **goniometer**

$$\alpha, \beta = \pm 8^\circ$$

$$\Delta\alpha, \Delta\beta = 2.5 \mu\text{rad}$$

## **supportable weight**

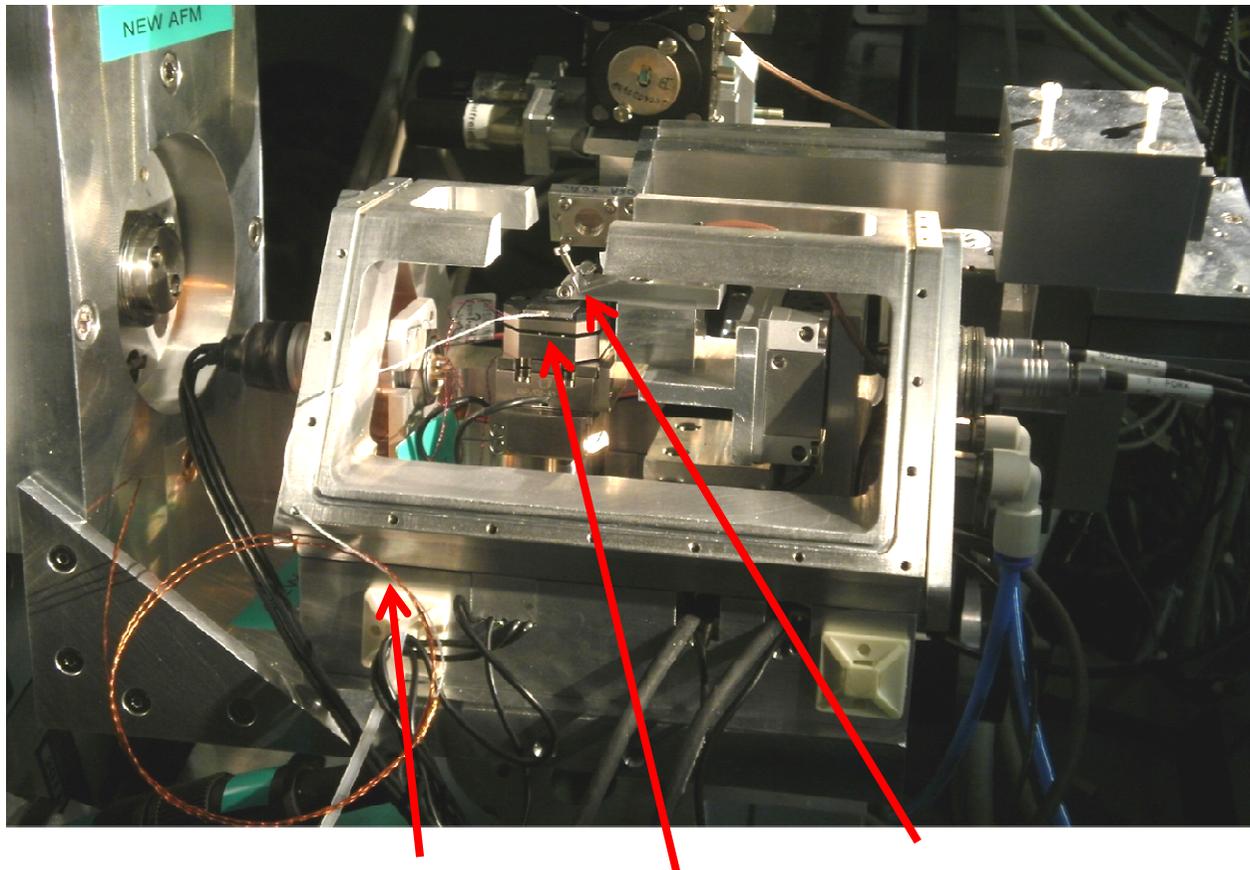
$$2 - 5 \text{ kg}$$

# Sample scanner+environments

Keep things as lightweight as possible:

- low elastic deformation during angular change
- use of piezo scanners together with sample environments

Like this: ....



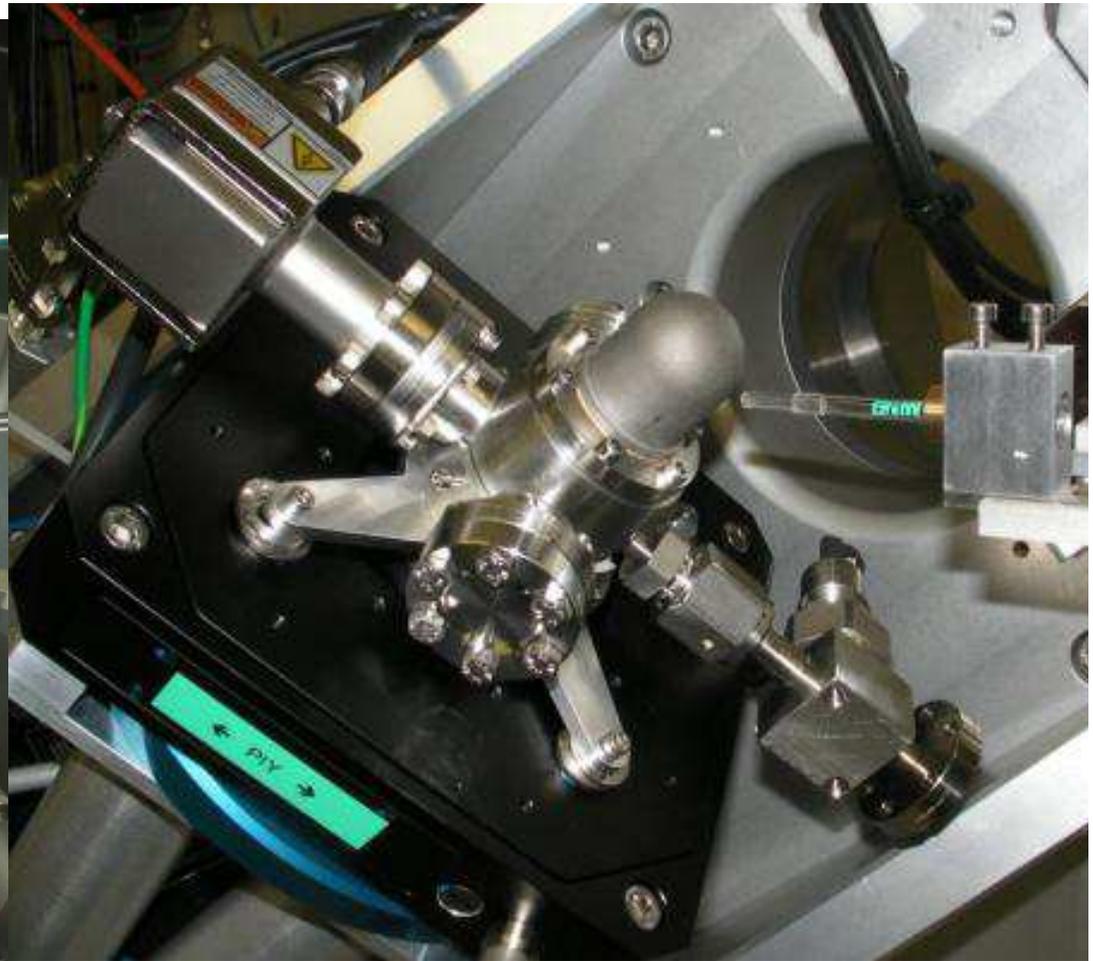
AFM housing with sample and tip on piezo positioners

# Sample scanner+environments

...or like this:



Highly compacted light weight AFM (400 g) inside vacuum chamber.  
Ensemble is carried on a piezo positioner (black table).



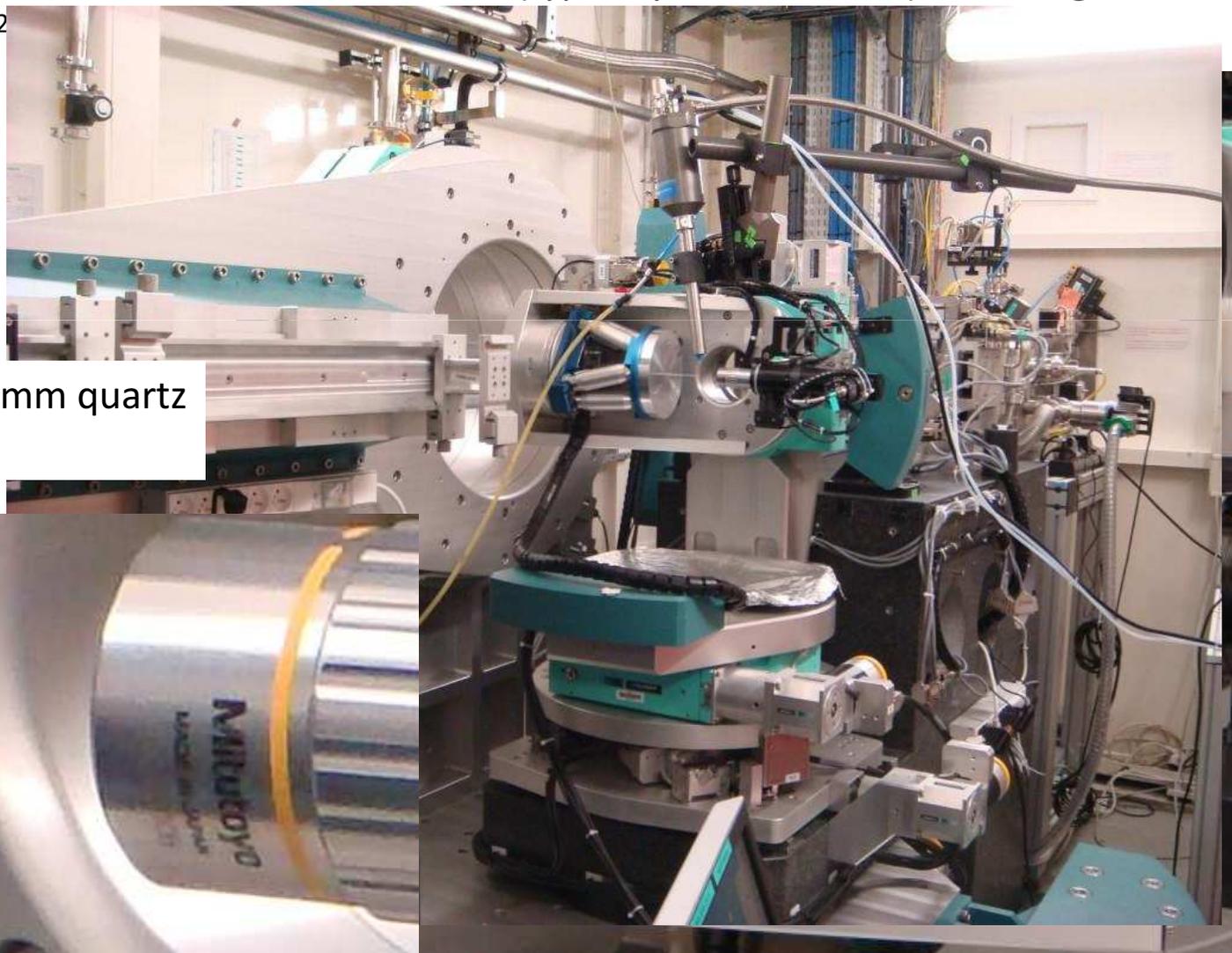
HV chamber "the Kilo"

## Grazing incidence diffraction from “difficult” samples

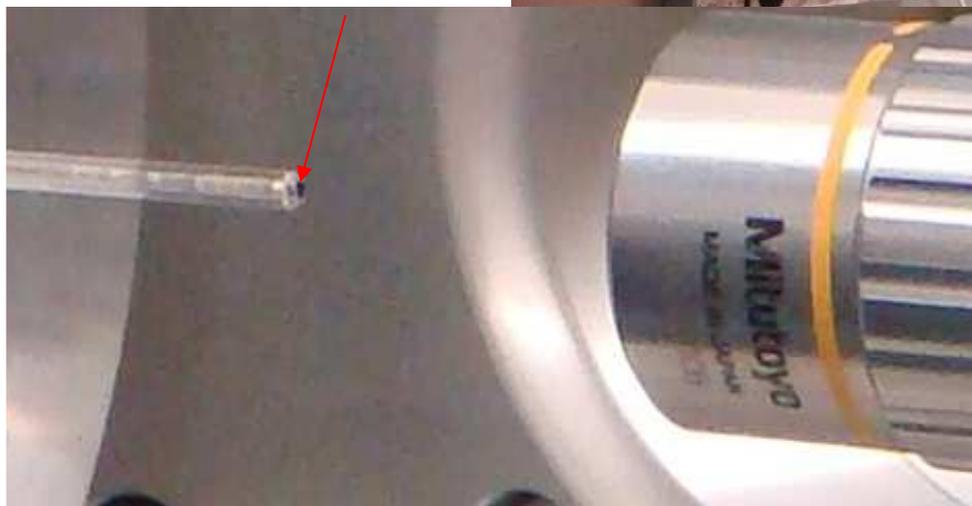
Grazing incidence diffraction (GID) from a “small” (5 mg) crystal:

e.g. facet  $< 1 \times 1 \text{ mm}^2$ , incidence at critical angle of  $0.2^\circ$ : efficient beam size:  $3\text{-}4 \text{ }\mu\text{m}$

Focusing in the plane of incidence with 1D Be lenses (typically at 6.5-15 KeV), resulting beam size:  $5 \times 1000 \text{ }\mu\text{m}^2$

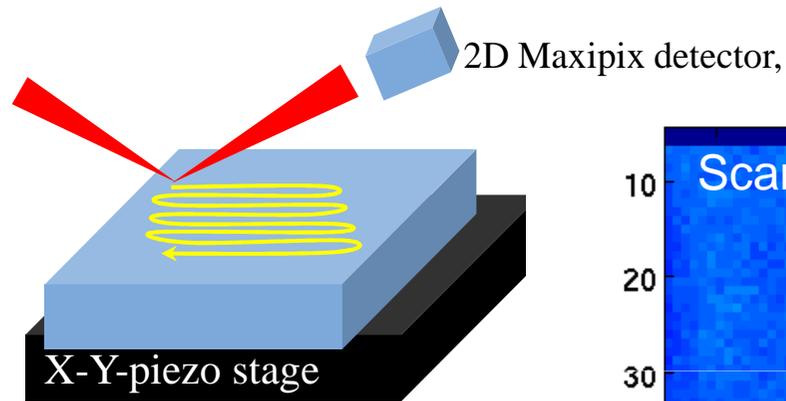


Small crystal fixed to a 3 mm quartz rod investigated in GID



# scanning diffraction microscopy : strain mapping

Continuous motion of the piezo-stage and synchronized acquisition of images from 2D detector and position from stage.



100x100 points map with micrometer resolution: The low intensity parts are highly strained

## Enormous gain in time

EX: 100x100 points

-SPEC>  $100 \times 100 \times (1s + 2,7s) = 37000 s \sim 10 \text{ hours}$

-FS=>  $100 \times 100 \times 0.04 = 400s$

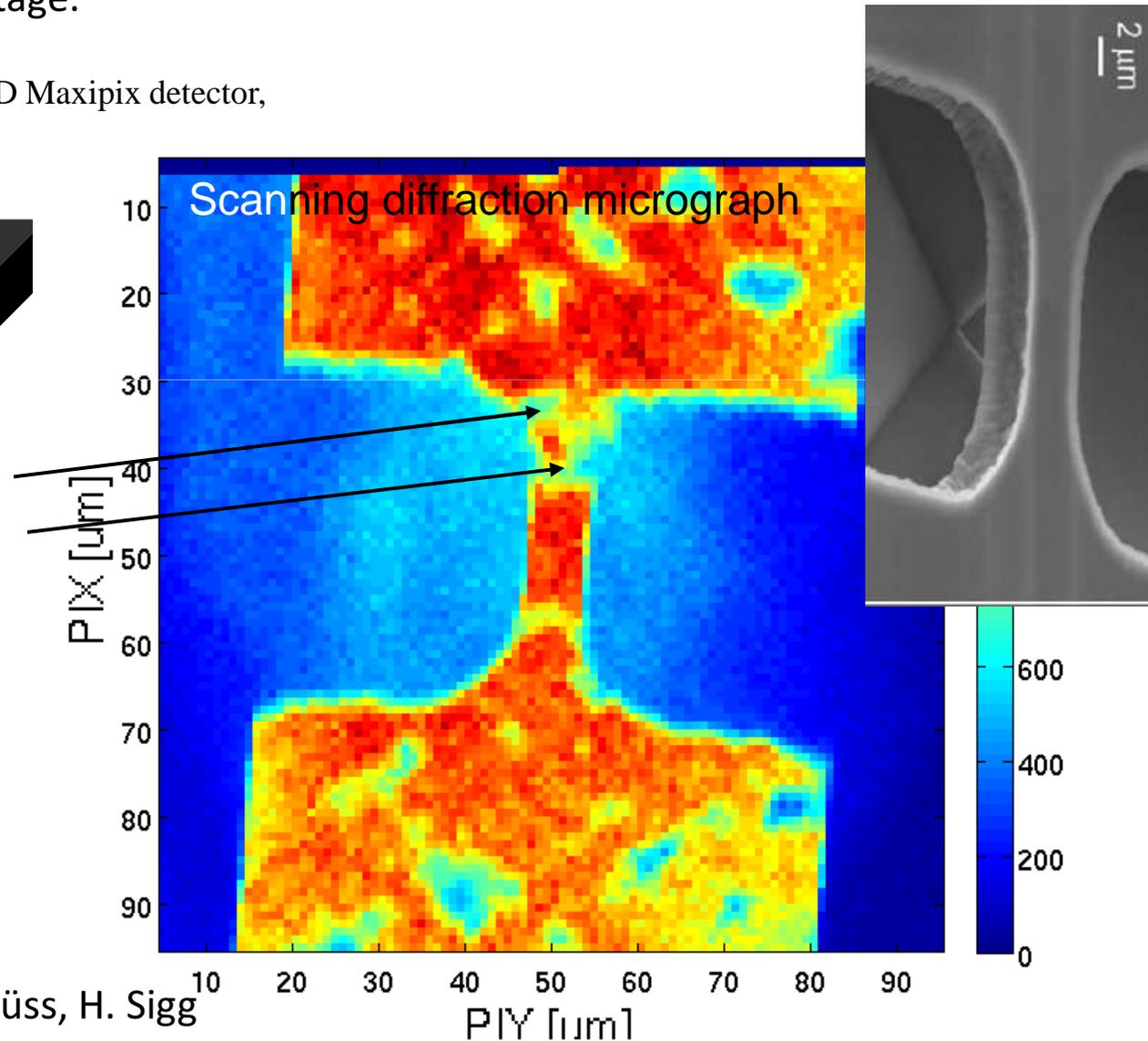


Image courtesy: A. Diaz, M. Süß, H. Sigg

# Hutch and diffractometer environment



Nano hutch checklist:

-silence !

Throw primary vacuum pumps out  
watch over all sources of vibrations at low  
frequencies (fans of turbo pumps)

-thermal stability

Avoid unnecessary heat sources (Halogen  
lamps)

Separately ventilate electronics which have  
to be close to experiment

Thermally insulate hutch

-rapid achievement of thermal equilibrium

# ID01 upgrade: Energy specifications and undulator combination

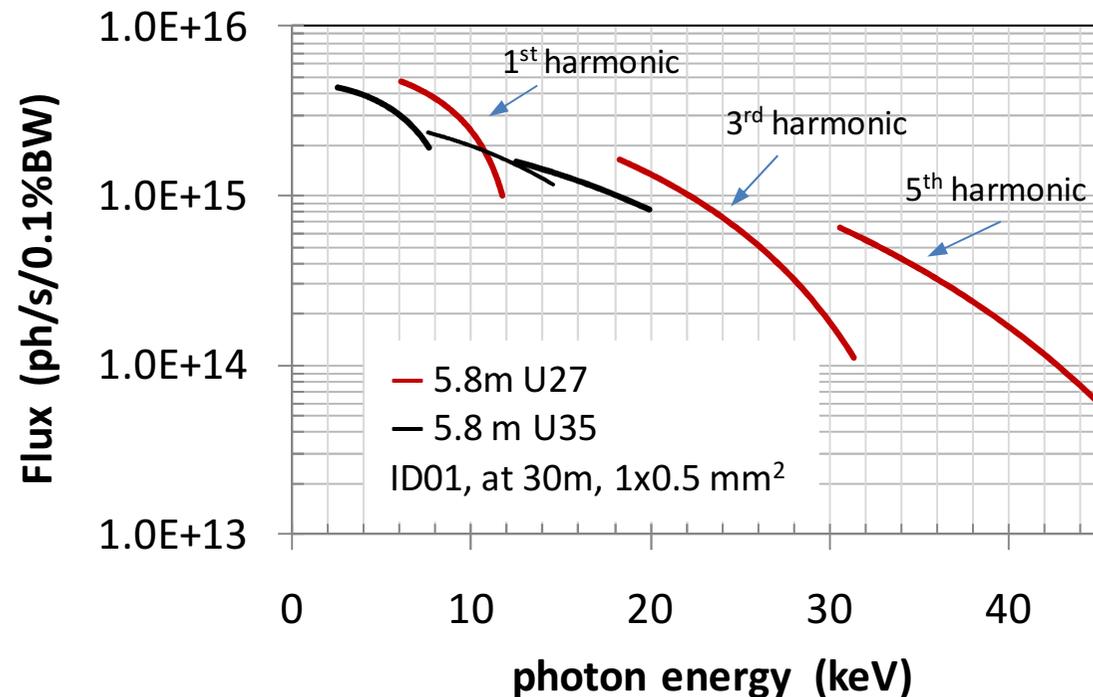
U35/ U27 (5.8 m) revolver setup to cover *complete energy* ((2.1...4.2-42...60 keV) range and optimize 3 energy regimes:

6-11 KeV: Coherence+Nanofocussing on 1<sup>st</sup> harmonic

18-25 KeV: Nanofocusing+ Diffraction

30-35 KeV: 1D/2D microfocusing/ transmission geometries

} Higher energies ease the use of “beryllium-free” sample environments



New id01 endstation at 115 m:

Granit bench and precision diffractometer

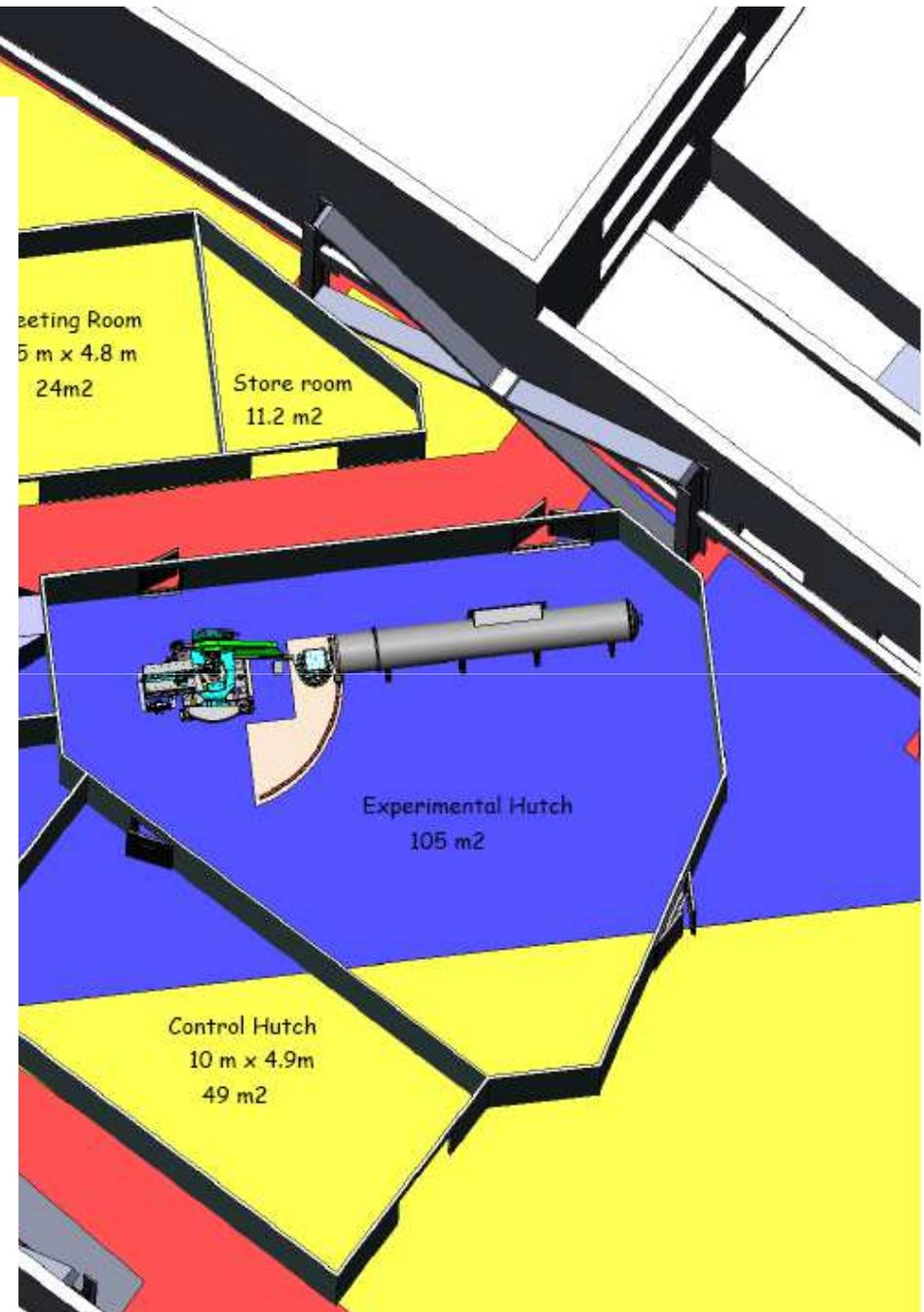
Easy choice of energy and focusing device  
Beamsizes 50 nm to 5 mm.

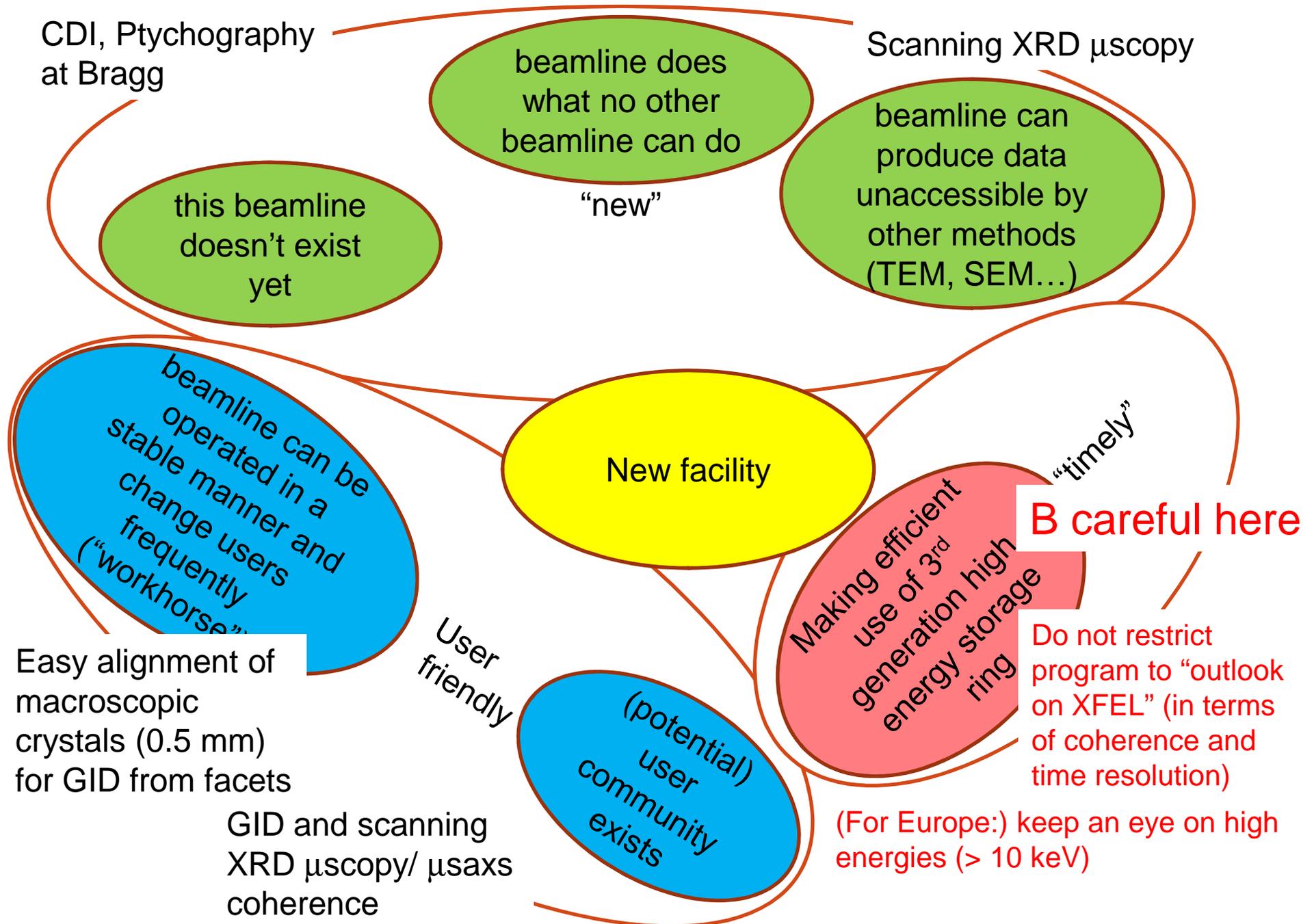
Long “saxs” tube available, also as 5 m detector arm for Coherence, Ptychography

Nano-compatible, compact sample environments (HV, reaction chambers, cryostat) prepared in house.

Heavy stage available for up to 150 Kg user equipment (horizontal scattering geometry only)

-> applied surface and “nanostructure” science (devices with heterogeneity on 100 nm scale, ageing processes, process steps in fabrication...)





acknowledgements

R. Grifone

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(Madison/  
Wisconsin)

T. Schulli

V. Jacques

F. Mastropietro

H. Djazouli

G. Chahine

P. Boesecke

